TSG RAN Meeting #13 **RP-010633**
Beijing, China, 18-21 September 2001

Title: **CRs (Rel-4) to TS 25.142**

Source **TSG RAN WG4**

Agenda item: **8.4.4**

RAN4 Tdoc	Spec	CR	Title	Cat	Phase	Curr Ver	New Ver
R4-010826	25.142	81	Differential accuracy of P-CCPCH power	B	Rel-4	4.1.0	4.2.0
R4-010949	25.142	82	Receiver spurious emissions for co-located base stations 1.28 Mcps TDD option	F	Rel-4	4.1.0	4.2.0
R4-011122	25.142	83	Correction of Test Requirements for Dynamic Range (1,28 Mcps TDD option)	F	Rel-4	4.1.0	4.2.0
R4-011124	25.142	84	Inclusion of test conditions for the 1,28 Mcps TDD option	F	Rel-4	4.1.0	4.2.0
R4-011136	25.142	85	Power and ACLR definition corrections for 1.28 Mcps TDD option	F	Rel-4	4.1.0	4.2.0
R4-011282	25.142	86	Correction of frequency range for receiver spurious emissions (1,28 Mcps TDD option)	F	Rel-4	4.1.0	4.2.0

3GPP TSG RAN WG4 Meeting #19 **R4-010826**

Edinburgh, Great Britain, 3rd - 7th September 2001

CR-Form-v4

CHANGE REQUEST

⌘ **25.142** **CR** 81 ⌘ ev **-** ⌘ Current version: **4.1.0** ⌘

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Proposed change affects: ⌘ (U)SIM ☐ ME/UE ☐ Radio Access Network **X** Core Network ☐

Title:	⌘	Differential accuracy of P-CCPCH
Source:	⌘	RAN WG4
Work item code:	⌘	TEI4
Date:	⌘	9 July 2001
Category:	⌘	**B**
Release:	⌘	Rel-4

Use one of the following categories:
F *(correction)*
A *(corresponds to a correction in an earlier release)*
B *(addition of feature),*
C *(functional modification of feature)*
D *(editorial modification)*
Detailed explanations of the above categories can be found in 3GPP TR 21.900.

Use one of the following releases:
2 (GSM Phase 2)
R96 (Release 1996)
R97 (Release 1997)
R98 (Release 1998)
R99 (Release 1999)
REL-4 (Release 4)
REL-5 (Release 5)

Reason for change:	⌘	Introduction of a new requirement for differential accuracy of P-CCPCH in the core specification TS 25.105 which requires the definition of a corresponding test description.
Summary of change:	⌘	Definition of a conformance test description for differential accuracy of P-CCPCH
Consequences if not approved:	⌘	The conformance test specification TS 25.142 would not cover all requirements specified in the corresponding core specification TS 25.105.

Clauses affected:	⌘	5.10.2; 5.11.1; 5.15; 6.4.5.4; 6.4.6 (new); Annex D; Annex E
Other specs affected:	⌘	☐ Other core specifications ⌘ ☐ Test specifications ☐ O&M Specifications
Other comments:	⌘	

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3) With "track changes" disabled, paste the entire CR form (use CTRL-A to select it) into the specification just in front of the clause containing the first piece of changed text. Delete those parts of the specification which are not relevant to the change request.

5.10.2 Measurement of transmitter

Table 5.3: Maximum Test System Uncertainty for transmitter tests

Subclause	Maximum Test System Uncertainty	Measurement range (see NOTE)
6.2 Maximum Output Power	± 0,7 dB	
6.3 Frequency stability	± 12 Hz	± 500 Hz
6.4.2 Power control steps	single step: ± 0,1 dB ten steps: ± 0,3 dB	
6.4.3 Power control dynamic range	± 0,3 dB	
6.4.4 Minimum transmit power	± 0,7 dB	
6.4.5 Primary CCPCH power	± 0,8 dB	
6.4.6 Differential accuracy of Primary CCPCH power	± 0,1 dB	
6.5.1 Transmit OFF power	± 2,0 dB	
6.5.2 Transmit ON/OFF time mask	Tx power limit = -79 dBm: ± 2,0 dB Tx power limit = -33 dBm: ± 0,7 dB	
6.6.1 Occupied Bandwidth	± 100 kHz	± 1,0 MHz
6.6.2.1 Spectrum emission mask	± 1,5 dB	
6.6.2.2 Adjacent Channel Leakage power Ratio (ACLR)	minimum requirement: 5 MHz offset: ± 0,8 dB 10 MHz offset: ± 0,8 dB requirement in case of operation in proximity to TDD BS or FDD BS operating on an adjacent frequency: 5 MHz offset: ± 4 dB 10 MHz offset: ± 4 dB requirement in case of co-siting with TDD BS or FDD BS operating on an adjacent frequency: 5 MHz offset: TBD 10 MHz offset: TBD Note: Impact of measurement period (averaging) and intermod effects in the measurement receiver not yet fully studied.	Signal power = PRAT
6.6.3 Spurious emissions	± 2,0 dB for BS and coexistence bands for results > -60 dBm ± 3,0 dB for results < -60 dBm Outside above range: f ≤ 2,2 GHz: ± 1,5 dB 2,2 GHz < f ≤ 4 GHz: ± 2,0 dB f > 4 GHz: ± 4,0 dB	
6.7 Transmit intermodulation	The value below applies to the setting of the interference signal level only and is unrelated to the measurement uncertainty of the tests (6.6.2.1, 6.6.2.2 and 6.6.3) which have to be carried out in the presence of the interference signal. Need to add formula for uncertainty of the ratio. 1 dB	Not applicable
6.8.1 Modulation accuracy	± 2,5 % (for single code)	± 5,0 % Signal power = PRAT to (PRAT –30 dB)
6.8.2 Peak code domain error	± 1 dB	Signal power = PRAT
NOTE: The Test System uncertainty applies for measurement results in a range equal to the DUT Test Requirement (not the Minimum Requirement) extended by the range specified.		

5.11.1 Transmitter

Table 5.6: Test Tolerance for transmitter tests

Subclause	Test Tolerance (see NOTE)
6.2 Maximum Output Power	0,7 dB
6.3 Frequency stability	12 Hz
6.4.2 Power control steps	single step: 0,1 dB ten steps: 0,3 dB
6.4.3 Power control dynamic range	0,3 dB
6.4.4 Minimum transmit power	0,7 dB
6.4.5 Primary CCPCH power	0,8 dB
6.5.1 Transmit OFF power	2,0 dB
6.4.6 Differential accuracy of Primary CCPCH power	± 0,1 dB
6.5.2 Transmit ON/OFF time mask	Tx power limit = -79 dBm: 2,0 dB Tx power limit = -33 dBm: 0,7 dB
6.6.1 Occupied Bandwidth	0 kHz
6.6.2.1 Spectrum emission mask	1,5 dB
6.6.2.2 Adjacent Channel Leakage power Ratio (ACLR)	minimum requirement: 0,8 dB operation in proximity: 4 dB co-siting: TBD
6.6.3 Spurious emissions	0 dB
6.7 Transmit intermodulation	Testing of transmit intermodulation consists of 3 parts: - testing of spectrum emission mask, see 6.6.2.1 - testing of ACLR, see 6.6.2.2 - testing of spurious emissions, see 6.6.3 For each of these parts, the respective Test Tolerances as specified in this table shall apply. Test Tolerance for setting of the interferer power level: 0 dB
6.8.1 Modulation accuracy	0 %
6.8.2 Peak code domain error	1 dB
NOTE: Unless otherwise stated, the Test Tolerances are applied to the DUT Minimum Requirement. See Annex D.	

5.15 Overview of the conformance test requirements

Tables 5.9, 5.10 and 5.11 give an overview of the conformance test requirements for the transmitter, the receiver and system performance, respectively.

Table 5.9: Overview of the conformance tests requirements for the transmitter

Parameter	Subclause	Note
Maximum output power	6.2	manufacturer's declaration required
Frequency stability	6.3	manufacturer's declaration required
Output power dynamics	6.4	
Inner loop power control	6.4.1	
Power control steps	6.4.2	
Power control dynamic range	6.4.3	
Minimum transmit power	6.4.4	
Primary CCPCH power	6.4.5	
Differential accuracy of Primary CCPCH power	6.4.6	
Transmit OFF power	6.5.1	
Transmit ON/OFF time mask	6.5.2	
Output RF spectrum emissions	6.6	
Occupied bandwidth	6.6.1	
Out-of-band emission	6.6.2	
Spectrum emission mask	6.6.2.1	manufacturer's declaration required
Adjacent Channel Leakage power Ratio (ACLR)	6.6.2.2	manufacturer's declaration required
Spurious emissions	6.6.3	
Mandatory requirements	6.6.3.2.1	manufacturer's declaration required
Co-existence with GSM 900	6.6.3.2.2	manufacturer's declaration required
Co-existence with DCS 1800	6.6.3.2.3	manufacturer's declaration required
Co-existence with UTRA FDD	6.6.3.2.4	manufacturer's declaration required
Transmit intermodulation	6.7	
Transmit modulation	6.8	
Modulation accuracy	6.8.1	
Peak code domain error	6.8.2	

6.4.5 Primary CCPCH power

6.4.5.1 Definition and applicability

Primary CCPCH power is the transmission power of the Primary Common Control Physical Channel averaged over the transmit timeslot. Primary CCPCH power is signaled on the BCH.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.5.2 Minimum Requirements

The error between the BCH-broadcast value of the Primary CCPCH power and the Primary CCPCH power averaged over the timeslot shall not exceed the values in table 6.8. The error is a function of the total power averaged over the timeslot, Pout, and the manufacturer's rated output power, PRAT.

Table 6.8: Errors between Primary CCPCH power and the broadcast value

Total power in slot, dB	PCCPCH power tolerance
PRAT - 3 < Pout ≤ PRAT + 2	+/- 2,5 dB
PRAT - 6 < P ≤ PRAT - 3	+/- 3,5 dB
PRAT - 13 < P ≤ PRAT - 6	+/- 5 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.5.

6.4.5.3 Test purpose

The power of the Primary CCPCH received by the UE, together with the information on the Primary CCPCH nominal transmit power signaled on the BCH, are used by the UE for path loss estimation and adjustment of its own transmit power. Therefore, deviations of the Primary CCPCH power from its nominal value are transposed by the UE into deviations from the wanted transmit power of the UE.

The test purpose is to verify that the Primary CCPCH power remains within its specified tolerances under normal and extreme conditions.

6.4.5.4 Method of test

6.4.5.4.1 Initial conditions

6.4.5.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the BS tester to the antenna connector of the BS under test. The BS tester must have the ability to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C.

(2~~1~~) Set the parameters of the BS transmitted signal according to table 6.9.

Table 6.9: Parameters of the BS transmitted signal for Primary CCPCH power testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Time slots carrying PCCPCH	TS 0 and TS 8
Number of additional DPCH in TS 0 and TS 8	3
BS output power setting	PRAT
Relative power of PCCPCH	¼ of BS output power
Relative power of each DPCH in TS 0 and TS 8	¼ of BS output power
Data content of DPCH	real life (sufficient irregular)

6.4.5.4.1.2 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test. The BS tester must have the ability to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C.

(2) Set the parameters of the BS transmitted signal according to table 6.9A.

Table 6.9A: Parameters of the BS transmitted signal for Primary CCPCH power testing for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
Time slots carrying PCCPCH	TS 0
BS output power setting	PRAT
Relative power of PCCPCH	½ of BS output power
Data content of DPCH	real life (sufficient irregular)

6.4.5.4.2 Procedure

6.4.5.4.2.1 3,84 Mcps TDD option

(1) Measure the PCCPCH power in TS 0 and TS 8 by applying the global in-channel Tx test method described in Annex C.

(2) Reduce the base station output power by 2 dB, 5 dB and 13 dB, without changing the relative powers of the PCCPCH and the DPCHs, and repeat step (1) for each output power setting.

6.4.5.4.2.2 1,28 Mcps TDD option

(1) Measure the PCCPCH power in TS 0 by applying the global in-channel Tx test method described in Annex C.

(2) Reduce the base station output power by 2 dB, 5 dB and 13 dB, without changing the relative powers of the PCCPCH and the DPCHs, and repeat step (1) for each output power setting.

6.4.5.5 Test Requirements

NOTE: If the Test Requirement below differs from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

The Primary CCPCH power, measured according to subclause 6.4.5.4.2, shall be within the limits defined in table 6.10

Table 6.10: Test Requirements for errors between Primary CCPCH power and the broadcast value

Total power in slot, dB	PCCPCH power tolerance
PRAT - 3 < Pout ≤ PRAT + 2	+/- 3,3 dB
PRAT - 6 < P ≤ PRAT - 3	+/- 4,3 dB
PRAT - 13 < P ≤ PRAT - 6	+/- 5,8 dB

6.4.6 Differential accuracy of Primary CCPCH power

6.4.6.1 Definition and applicability

The differential accuracy of the Primary CCPCH power is the relative transmitted power accuracy of PCCPCH in consecutive frames when the nominal PCCPCH power is not changed.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.6.2 Minimum Requirements

The differential accuracy of PCCPCH power shall be within ± 0,5 dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.6.

6.4.6.3 Test purpose

The power of the Primary CCPCH received by the UE, together with the information on the Primary CCPCH nominal transmit power signaled on the BCH, are used by the UE for path loss estimation and adjustment of its own transmit power. Therefore, a lack of accuracy of the Primary CCPCH power over time will result in unwanted fluctuations of the transmit power of the UE which may degrade system performance.

The test purpose is to verify that the differential accuracy of the Primary CCPCH power remains within its specified tolerances.

6.4.6.4 Method of test

6.4.6.4.1 Initial conditions

6.4.6.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the BS tester to the antenna connector of the BS under test. The BS tester must have the ability to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C.

(2) Set the parameters of the BS transmitted signal according to table 6.10A.

Table 6.10A: Parameters of the BS transmitted signal for testing of differential accuracy of the Primary CCPCH power

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Time slots carrying PCCPCH	TS 0 and TS 8
Number of additional DPCH in TS 0 and TS 8	3
BS output power setting	PRAT
Relative power of PCCPCH	¼ of BS output power
Relative power of each DPCH in TS 0 and TS 8	¼ of BS output power
Data content of DPCH	real life (sufficient irregular)

6.4.6.4.1.2 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test. The BS tester must have the ability to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C.

(2) Set the parameters of the BS transmitted signal according to table 6.9A.

Table 6.10B: Parameters of the BS transmitted signal for testing of differential accuracy of the Primary CCPCH power for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
Time slots carrying PCCPCH	TS 0
BS output power setting	PRAT
Relative power of PCCPCH	½ of BS output power
Data content of DPCH	real life (sufficient irregular)

6.4.6.4.2 Procedure

6.4.6.4.2.1 3,84 Mcps TDD option

(1) Measure the PCCPCH power in TS 0 and TS 8 of consecutive frames by applying the global in-channel Tx test method described in Annex C.

(2) Calculate the differential accuracy of the Primary CCPCH power by taking the the difference between the PCCPCH power measurement results of consecutive frames.

6.4.6.4.2.2 1,28 Mcps TDD option

(1) Measure the PCCPCH power in TS 0 of consecutive frames by applying the global in-channel Tx test method described in Annex C.

(2) Calculate the differential accuracy of the Primary CCPCH power by taking the the difference between the PCCPCH power measurement results of consecutive frames.

6.4.6.5 Test Requirements

NOTE: If the Test Requirement below differs from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

The differential accuracy of the Primary CCPCH power, measured according to subclause 6.4.6.4.2, shall be within ± 0,6 dB.

Annex D (informative): Derivation of Test Requirements

The Test Requirements in this specification have been calculated by relaxing the Minimum Requirements of the core specification using the Test Tolerances defined in subclause 5.11. When the Test Tolerance is zero, the Test Requirement will be the same as the Minimum Requirement. When the Test Tolerance is non-zero, the Test Requirements will differ from the Minimum Requirements, and the formula used for this relaxation is given in tables D.1 to D.3

Note that a formula for applying Test Tolerances is provided for all tests, even those with a test tolerance of zero. This is necessary in the case that the Test System uncertainty is greater than that allowed in subclause 5.10. In this event, the excess error shall be subtracted from the defined test tolerance in order to generate the correct tightened Test Requirements as defined in subclause 5.12.

For example, a Test System having 0,9 dB accuracy for test 6.2 Maximum output power (which is 0,2 dB above the limit specified in subclause 5.10.2) would subtract 0,2 dB from the Test Tolerance of 0,7 dB defined in subclause 5.11.1. This new test tolerance of 0,5 dB would then be applied to the Minimum Requirement using the formula defined in Table D.1 to give a new range of ±2,5 dB of the manufacturer's rated output power.

For the case where an excess error of 0.2 dB exists, when applied to a test with a test tolerance of zero, the test tolerance used in the formula would be –0.2 dB.

Table D.1: Derivation of Test Requirements (Transmitter tests)

Test	Minimum Requirement in TS 25.105 (numbering of tables in the column below refers to TS 25.142)	Test Tolerance (TT)	Test Requirement in TS 25.142
6.2 Maximum output power	In normal conditions … within +2 dB and –2 dB of the manufacturer's rated output power In extreme conditions… within +2,5 dB and –2,5 dB of the manufacturer's rated output power	0,7 dB	Formula: Upper limit + TT Lower limit – TT In normal conditions … within +2,7 dB and –2,7 dB of the manufacturer's rated output power In extreme conditions… within +3,2 dB and –3,2 dB of the manufacturer's rated output power
6.3 Frequency stability	Frequency stability = ± 0,05 ppm	12 Hz	Formula: ± (frequency stability +TT) ± (0,05 ppm + 12 Hz)
6.4.2 Power control steps	single step: step size tolerance specified in table 6.3 ten steps: minimum and maximum average rate of change in mean power specified in table 6.3	single step: 0,1 dB ten steps: 0,3 dB	Formula: single step: ± (step size tolerance + TT) ten steps: maximum average rate + TT minimum average rate – TT 0,1 dB and 0,3 dB, respectively, applied as above to table 6.3
6.4.3 Power control dynamic range	range ≥ 30 dB	0,3 dB	Formula: Range – TT range ≥ 29,7 dB
6.4.4 Minimum transmit power	PRAT – 30 dB	0,7 dB	Formula : PRAT – 30 dB +TT PRAT – 29,3 dB
6.4.5 Primary CCPCH power	PCCPCH power tolerance defined in table 6.8	0,8 dB	Formula: ± (power tolerance + TT) 0,8 dB applied as above to table 6.8
6.4.6 Differential accuracy of Primary CCPCH power	Differential accuracy of PCCPCH power: ≤ ± 0,5 dB	0,1 dB	Formula: ± (PCCPCH tolerance + TT) ± 0,6 dB
6.5.1 Transmit OFF power	Tx OFF power limit < -79 dBm	2,0 dB	Formula: < Tx OFF power limit + TT < - 77 dBm
6.5.2 Transmit ON/OFF time mask	Tx power limit < -33 dBm or –79 dBm, resp.	< -33 dBm: 0,7 dB < -79 dBm: 2,0 dB	Formula: < Tx power limit + TT < -32,3 dBm or < - 77 dBm

6.6.1 Occupied bandwidth	occupied bandwidth limit = 5 MHz	0 kHz	Formula: Occupied bandwidth limit + TT Occupied bandwidth limit = 5 MHz
6.6.2.1 Spectrum emission mask	Maximum level defined in tables 6.13 to 6.16	1,5 dB	Formula: Maximum level + TT Add 1,5 dB to Maximum level entries in tables 6.13 to 6.16
6.6.2.2 Adjacent Channel Leakage power Ratio (ACLR)	minimum requirement: ACLR limit = 45 dB at 5 MHz ACLR limit = 55 dB at 10 MHz requirement in case of operation in proximity to TDD BS or FDD BS operating on an adjacent frequency: ACLR limit = 70 dB at 5 MHz ACLR limit = 70 dB at 10 MHz requirement in case of co-siting with TDD BS or FDD BS operating on an adjacent frequency ACLR limit = - 80 dBm at 5 MHz ACLR limit = - 80 dBm at 10 MHz	min. req. : 0,8 dB operation in proxim.: 4 dB co-siting: TBD	Formula: ACLR limit – TT min. requirement: ACLR limit = 44,2 dB at 5 MHz ACLR limit = 54,2 dB at 10 MHz operation in proximity: ACLR limit = 66 dB at 5 MHz ACLR limit = 66 dB at 10 MHz co-siting: TBD
6.6.3 Spurious emissions	maximum level defined in tables 6.29 to 6.37	0 dB	Formula: Maximum limit + TT add 0 dB to maximum levels in tables 6.29 to 6.37
6.7 Transmit intermodulation (interferer requirements) This tolerance applies to the stimulus and not the measurements defined in 6.6.2.1, 6.6.2.2 and 6.6.3.	Wanted signal level – interferer level = 30 dB	0 dB	Formula: Ratio + TT Wanted signal level – interferer level = 30 + 0 dB
6.8.1 Modulation accuracy	EVM limit = 12,5 %	0 %	Formula: EVM limit + TT EVM limit = 12,5 %
6.8.2 Peak code domain error	PCDE limit = - 28 dB	1 dB	Formula: PCDE limit + TT PCDE limit = - 27 dB

Annex E (informative): Acceptable uncertainty of Test Equipment

This informative annex specifies the critical parameters of the components of an overall Test System (e.g. Signal generators, Signal Analysers etc.) which are necessary when assembling a Test System which complies with subclause 5.10 Acceptable Uncertainty of Test System. These Test Equipment parameters are fundamental to the accuracy of the overall Test System and are unlikely to be improved upon through System Calibration.

Table E.1: Equipment accuracy for transmitter measurements

Test	Equipment accuracy	Range (see NOTE)
6.2 Maximum output power	Not critical	Not critical
6.3 Frequency stability	± 10 Hz + timebase = 12 Hz	± 500 Hz. (This is to allow for UE range that at 0,1 PPM is larger than BTS.)
6.4.2 Power control steps	single step: ± 0,1 dB ten steps: ± 0,3 dB	
6.4.3 Power control dynamic range	± 0,3 dB	
6.4.4 Minimum transmit power	Not critical	Not critical
6.4.5 Primary CCPCH power	Not critical	Not critical
6.4.6 Differential accuracy of Primary CCPCH power	± 0,1 dB	
6.5.1 Transmit OFF power	Not critical	Not critical
6.5.2 Transmit ON/OFF time mask	Not critical	Not critical
6.6.1 Occupied bandwidth	± 100 kHz	± 1 MHz
6.6.2.1 Spectrum emission mask	Not critical	Not critical
6.6.2.2 ACLR	minimum requirement: ± 0,8 dB requirement in case of operation in proximity: ± 4,0 dB requirement in case of co-siting: TBD	
6.6.3 Spurious emissions	Not critical	Not critical
6.7 Transmit intermodulation (interferer requirements)	Not critical	Not critical
6.8.1 Modulation accuracy	± 2,5 % (for single code)	Signal power = PRAT to (PRAT – 30 dB) Specified accuracy applies to measurement results between ± 7,5% and 17,5%
6.8.2 Peak code domain error	± 1 dB	
NOTE: The Test Equipment uncertainty applies for measurement results in a range equal to the DUT Test Requirement (not the Minimum Requirement) extended by the range specified.		

3GPP TSG RAN WG4 Meeting #19 **R4-010949**

Edinburgh, Great Britain, 3rd - 7th September 2001

CR-Form-v3

CHANGE REQUEST

⌘ **25.142** **CR** **82** ⌘ rev **-** ⌘ Current version: **4.1.0** ⌘

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Proposed change affects: ⌘ (U)SIM ☐ ME/UE ☐ Radio Access Network ☒ Core Network ☐

Title:	⌘	Receiver spurious emission for co-located base stations for 1.28 Mcps TDD option
Source:	⌘	RAN WG4
Work item code:	⌘	LCRTDD-RF
Date:	⌘	2001-07-03
Category:	⌘	**F**
Release:	⌘	Rel-4

Use one of the following categories:
- ***F*** *(essential correction)*
- ***A*** *(corresponds to a correction in an earlier release)*
- ***B*** *(Addition of feature),*
- ***C*** *(Functional modification of feature)*
- ***D*** *(Editorial modification)*

Detailed explanations of the above categories can be found in 3GPP TR 21.900.

Use one of the following releases:

2	*(GSM Phase 2)*
R96	*(Release 1996)*
R97	*(Release 1997)*
R98	*(Release 1998)*
R99	*(Release 1999)*
REL-4	*(Release 4)*
REL-5	*(Release 5)*

Reason for change:	⌘	In case of separate RX and TX antenna port the receiver is currently allowed to have more spurious emission than the transmitter in case of co-located base stations.
Summary of change:	⌘	Adding requirements for receiver spurious emission in case of separate RX and TX antenna port. The requirements are in line with the current transmitter requirements for co-located base stations.
Consequences if not approved:	⌘	Reduced performance of the co-located base station caused by receiver spurious emission.

Clauses affected:	⌘	7.7.2.2		
Other specs Affected:	⌘	☒ Other core specifications ☐ Test specifications ☐ O&M Specifications	⌘	3GPP TS 25.105
Other comments:	⌘			

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3) With "track changes" disabled, paste the entire CR form (use CTRL-A to select it) into the specification just in front of the clause containing the first piece of changed text. Delete those parts of the specification, which are not relevant to the change request.

7.7.2.2 1,28 Mcps TDD option

The power of any spurious emission shall not exceed the values given in table 7.12A.

Table 7.12A: Receiver spurious emission requirements for 1,28 Mcps TDD

Band	Maximum level	Measurement Bandwidth	Note
9 kHz – 1 GHz	-57 dBm	100 kHz	
1 GHz – 1.9 GHz and 1.98 GHz – 2.01 GHz	-47 dBm	1 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.
1.9 GHz – 1.98 GHz and 2.01 GHz – 2.025 GHz	-83 dBm	1.28 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.
2.025 GHz – 12.75 GHz	-47 dBm	1 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.

In addition to the requirements in table 7.12A, the co-existence requirements for co-located base stations in subclauses 6.6.3.2.2.2, 6.6.3.2.3.2 and 6.6.3.2.4.2 may also be applied.

The normative reference for this requirement is TS 25.105 [1] subclause 7.7.1.

3GPP TSG RAN WG4 Meeting #19 **R4-011122**

Edinburgh, Great Britain, 3rd - 7th September 2001

CR-Form-v4

CHANGE REQUEST

⌘ **25.142** **CR** 83 ⌘ ev **-** ⌘ Current version: **4.1.0** ⌘

*For **HELP** on using this form, see bottom of this page or look at the pop-up text over the ⌘ symbols.*

Proposed change affects: ⌘ (U)SIM ☐ ME/UE ☐ Radio Access Network ☒ Core Network ☐

Title:	⌘	Correction of Test Requirements for Dynamic Range (1,28 Mcps TDD option)
Source:	⌘	RAN WG4
Work item code:	⌘	LCRTDD-RF
Date:	⌘	3 September 2001
Category:	⌘	**F**
Release:	⌘	Rel-4

Use one of the following categories:
F *(correction)*
A *(corresponds to a correction in an earlier release)*
B *(addition of feature),*
C *(functional modification of feature)*
D *(editorial modification)*
Detailed explanations of the above categories can be found in 3GPP TR 21.900.

Use one of the following releases:

2	*(GSM Phase 2)*
R96	*(Release 1996)*
R97	*(Release 1997)*
R98	*(Release 1998)*
R99	*(Release 1999)*
REL-4	*(Release 4)*
REL-5	*(Release 5)*

Reason for change:	⌘	The Test Requirements for Dynamic Range specified in table 7.4 do not take into account that the level of the interfering AWGN signal in case of the 1,28 Mcps TDD option diverges from the level in case of the 3,84 Mcps TDD option.
Summary of change:	⌘	Introduction of a new table 7.4A specifying the Test Requirements for Dynamic Range in case of the 1,28 Mcps TDD option
Consequences if not approved:	⌘	The conformance testing for Dynamic Range in case of the 1,28 Mcps TDD option would be done with incorrect setting of the interfering AWGN signal level.

Clauses affected:	⌘	7.3.5; new subclauses 7.3.5.1 and 7.3.5.2
Other specs affected:	⌘	☐ Other core specifications ☐ Test specifications ☐ O&M Specifications ⌘
Other comments:	⌘	

How to create CRs using this form:
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1) Fill out the above form. The symbols above marked ⌘ contain pop-up help information about the field that they are closest to.

2) Obtain the latest version for the release of the specification to which the change is proposed. Use the MS Word "revision marks" feature (also known as "track changes") when making the changes. All 3GPP specifications can be downloaded from the 3GPP server under ftp://ftp.3gpp.org/specs/ For the latest version, look for the directory name with the latest date e.g. 2001-03 contains the specifications resulting from the March 2001 TSG meetings.

3) With "track changes" disabled, paste the entire CR form (use CTRL-A to select it) into the specification just in front of the clause containing the first piece of changed text. Delete those parts of the specification which are not relevant to the change request.

7.3 Dynamic range

7.3.1 Definition and applicability

Receiver dynamic range is the receiver ability to handle a rise of interference in the reception frequency channel. The receiver shall fulfil a specified BER requirement for a specified sensitivity degradation of the wanted signal in the presence of an interfering AWGN signal in the same reception frequency channel.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.3.2 Minimum Requirements

7.3.2.1 3,84 Mcps TDD option

The BER shall not exceed 0,001 for the parameters specified in table 7.3.

Table 7.3: Dynamic Range

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	<REFSENS> + 30 dB	dBm
Interfering AWGN signal	-73	dBm/3,84 MHz

7.3.2.2 1,28 Mcps TDD option

The BER shall not exceed 0,001 for the parameters specified in table 7.3A.

Table 7.3A: Dynamic Range for 1,28 Mcps TDD

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	<REFSENS> + 30 dB	dBm
Interfering AWGN signal	-76	dBm/1,28 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 7.3.

7.3.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed single-code test signal of maximum input power under defined conditions (specified interference, no multipath) with a BER not exceeding a specified limit.

7.3.4 Method of test

7.3.4.1 Initial conditions

7.3.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the BS tester (UE simulator), generating the wanted signal, and a band-limited white noise source, generating the interfering AWGN signal, to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12,2 kbps) defined in Annex A.2.1.

(4) The level of the BS tester output signal measured at the BS antenna connector shall be adjusted as specified in table 7.4.

(5) The power spectral density of the band-limited white noise source measured at the BS antenna connector shall be adjusted as specified in table 7.4. The minimum bandwidth of the white noise source shall be 1,5 times the chip rate (5,76 MHz for a chip rate of 3,84 MHz).

7.3.4.1.2 1,28 Mcps TDD option

(1) Connect the BS tester (UE simulator), generating the wanted signal, and a band-limited white noise source, generating the interfering AWGN signal, to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12.2 kbps) defined in Annex A.2.1.

(4) The level of the BS tester output signal measured at the BS antenna connector shall be adjusted as specified in table 7.3A.

(5) The power spectral density of the band-limited white noise source measured at the BS antenna connector shall be adjusted as specified in table 7.3A. The minimum bandwidth of the white noise source shall be 1,5 times the chip rate (2,4 MHz for a chip rate of 1,28 MHz).

7.3.4.2 Procedure

(1) Measure the BER by comparing the bit sequence of the information data transmitted by the BS tester with the bit sequence obtained from the BS receiver.

(2) Interchange the connections of the BS Rx ports and repeat the measurement according to (1)

7.3.5 Test Requirements

NOTE: If the Test Requirement below differs from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

7.3.5.1 3,84 Mcps TDD option

For any BS Rx port tested, the measured BER shall not exceed 0,001 for the parameters specified in table 7.4.

Table 7.4: Test Requirements for Dynamic Range

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	<REFSENS> + 31,2 dB	dBm
Interfering AWGN signal	-73	dBm/3,84 MHz

7.3.5.2 1,28 Mcps TDD option

For any BS Rx port tested, the measured BER shall not exceed 0,001 for the parameters specified in table 7.4A.

Table 7.4A: Test Requirements for Dynamic Range for 1,28 Mcps TDD option

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	<REFSENS> + 31,2 dB	dBm
Interfering AWGN signal	-76	dBm/1,28 MHz

3GPP TSG RAN WG4 Meeting #19 **R4-011124**

Edinburgh, Great Britain, 3rd - 7th September 2001

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CHANGE REQUEST

⌘ **25.142** **CR** 84 ⌘ ev **-** ⌘ Current version: **4.1.0** ⌘

*For **HELP** on using this form, see bottom of this page or look at the pop-up text over the ⌘ symbols.*

Proposed change affects: ⌘ (U)SIM ☐ ME/UE ☐ Radio Access Network ☒ Core Network ☐

Title:	⌘	Inclusion of test conditions for the 1,28 Mcps TDD option
Source:	⌘	RAN WG4
Work item code:	⌘	LCRTDD-RF
Date:	⌘	3 September 2001
Category:	⌘	**F**
Release:	⌘	Rel-4

Use one of the following categories:
F *(correction)*
A *(corresponds to a correction in an earlier release)*
B *(addition of feature),*
C *(functional modification of feature)*
D *(editorial modification)*
Detailed explanations of the above categories can be found in 3GPP TR 21.900.

Use one of the following releases:
2 (GSM Phase 2)
R96 (Release 1996)
R97 (Release 1997)
R98 (Release 1998)
R99 (Release 1999)
REL-4 (Release 4)
REL-5 (Release 5)

Reason for change:	⌘	Missing specifications of the test conditions (test environment and RF channels to be tested) for the 1,28 Mcps TDD option
Summary of change:	⌘	Shifting of the section on test conditions for each parameter from a subsection specific to the 3,84 Mcps TDD option to a section common for both TDD options. Updating of references to subclauses of the relevant core specification TS 25.105.
Consequences if not approved:	⌘	Incomplete definition of the test conditions in case of the 1,28 Mcps TDD option may result in non-consistent conformance testing results.

Clauses affected:	⌘	various subclauses in 6; 7; 8
Other specs affected:	⌘	☐ Other core specifications ☐ Test specifications ☐ O&M Specifications ⌘
Other comments:	⌘	

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3) With "track changes" disabled, paste the entire CR form (use CTRL-A to select it) into the specification just in front of the clause containing the first piece of changed text. Delete those parts of the specification which are not relevant to the change request.

6 Transmitter characteristics

6.1 General

Unless otherwise stated, all measurements shall be made at the BS antenna connector.

6.2 Maximum output power

6.2.1 Definition and applicability

Output power, Pout, of the base station is the power of one carrier delivered to a load with resistance equal to the nominal load impedance, when averaged (in the sense of thermal power) over the useful part of the burst (time slot).

Rated output power, PRAT, of the base station is the mean power level per carrier over an active timeslot that the manufacturer has declared to be available at the antenna connector.

Maximum output power, Pmax, of the base station is the mean power level per carrier over an active timeslot measured at the antenna connector for a specified reference condition.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.2.2 Minimum Requirements

In normal conditions, the base station maximum output power shall remain within +2 dB and –2 dB of the manufacturer's rated output power.

In extreme conditions, the base station maximum output power shall remain within +2,5 dB and –2,5 dB of the manufacturer's rated output power.

In certain regions, the minimum requirement for normal conditions may apply also for some conditions outside the ranges defined for the Normal test environment in subclause 5.9.1.

The normative reference for this requirement is TS 25.105 [1] subclause 6.2.1.1.

6.2.3 Test purpose

The test purpose is to verify the accuracy of the maximum output power across the frequency range and under normal and extreme conditions for all transmitters in the BS.

6.2.4 Method of test

6.2.4.1 Initial conditions

6.2.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

In addition, on one UARFCN only, the test shall be performed under extreme power supply as defined in subclause 5.9.4.

NOTE: Tests under extreme power supply also test extreme temperature.

6.2.4.1.~~2~~1 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

~~In addition, on one UARFCN only, the test shall be performed under extreme power supply as defined in subclause 5.9.4.~~

~~NOTE: Tests under extreme power supply also test extreme temperature.~~

(1) The transmitter under test and all other transmitters of the base station (if any) are switched on.

(2) The power of the transmitters not under test (if any) are controlled down.

(3) Connect the power measuring equipment to the BS antenna connector.

(4) Set the parameters of the transmitted signal according to table 6.1.

Table 6.1: Parameters of the transmitted signal for maximum output power test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.2.4.1.~~3~~2 1,28 Mcps TDD option

(1) The transmitter under test and all other transmitters of the base station (if any) are switched on.

(2) The power of the transmitters not under test (if any) are controlled down.

(3) Connect the power measuring equipment to the BS antenna connector.

(4) Set the parameters of the transmitted signal according to table 6.1A.

Table 6.1A: Parameters of the transmitted signal for maximum output power test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, 3, 4, 5, 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
BS output power setting	PRAT
Number of DPCH in each active TS	8
Power of each DPCH	1/8 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.3 Frequency stability

6.3.1 Definition and applicability

Frequency stability is the ability of the BS to transmit at the assigned carrier frequency.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.3.2 Minimum Requirements

The BS frequency stability shall be within ± 0,05 ppm observed over a period of one timeslot.

The normative reference for this requirement is TS 25.105 [1] subclause 6.3.1.1 for the 3,84 Mcps TDD option and subclause 6.3.1.2 for the 1,28 Mcps TDD option.

TS 25.105 subclause 6.3 specifies the additional requirement that the BS shall use the same frequency source for both RF generation and the chip clock. Compliance with this requirement is demonstrated by manufacturer's declaration; see subclause 5.4; a dedicated conformance test for this requirement is not defined.

6.3.3 Test purpose

The test purpose is to verify the accuracy of the carrier frequency across the frequency range and under normal and extreme conditions.

6.3.4 Method of test

6.3.4.1 Initial conditions

6.3.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

The following additional test shall be performed:

On each of B, M and T, the test shall be performed under extreme power supply as defined in subclause 5.9.4.

NOTE: Tests under extreme power supply also test extreme temperature.

6.3.4.1.2 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

~~The following additional test shall be performed:~~

~~On each of B, M and T, the test shall be performed under extreme power supply as defined in subclause 5.9.4.~~

~~NOTE: Tests under extreme power supply also test extreme temperature.~~

(1) The transmitter under test and all other transmitters of the base station (if any) are switched on.

(2) The power of the transmitters not under test (if any) are controlled down.

(3) Connect the tester to the BS antenna connector.

(4) Set the parameters of the transmitted signal according to table 6.2.

Table 6.2: Parameters of the transmitted signal for frequency stability test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	1
BS output power setting	PRAT
Data content of DPCH	real life (sufficient irregular)

6.3.4.1.3~~2~~ 1,28 Mcps TDD option

(1) The transmitter under test and all other transmitters of the base station (if any) are switched on.

(2) The power of the transmitters not under test (if any) are controlled down.

(3) Connect the tester to the BS antenna connector.

(4) Set the parameters of the transmitted signal according to table 6.2A.

Table 6.2A: Parameters of the transmitted signal for Frequency stability test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 6: transmit, if i is 0, 4,5,6; receive, if i is 1,2,3.
Number of DPCH in each active TS	1
BS output power setting	PRAT
Data content of DPCH	real life (sufficient irregular)

6.4 Output power dynamics

6.4.1 Inner loop power control

Inner loop power control is the ability of the BS transmitter to adjust its output power in response to the UL received signal.

For inner loop correction on the Downlink Channel, the base station adjusts the mean output power level of a CCTrCH in response to each valid power control bit received from the UE on the Uplink Traffic Channel based on the mapping of the TPC bits in uplink CCTrCH to downlink CCTrCH. Inner loop control is based on SIR measurements at the UE receiver, and the corresponding TPC commands are generated by the UE.

6.4.2 Power control steps

6.4.2.1 Definition and applicability

The power control step is the step change in the DL transmitter output power in response to a TPC message from the UE.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.2.2 Minimum Requirements

The power control step sizes in the DL shall be 1 dB, 2 dB and 3 dB.

The tolerance of the transmitter output power and the greatest average rate of change in mean power due to the power control step shall be within the range shown in Table 6.3.

Table 6.3: Power control step size tolerance

Step size	Tolerance	Range of average rate of change in mean power per 10 steps	
		Minimum	maximum
1dB	± 0,5 dB	± 8 dB	± 12 dB
2dB	± 0,75 dB	± 16 dB	± 24 dB
3dB	± 1 dB	± 24 dB	± 36 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.2.1.

6.4.2.3 Test purpose

The DL power control is applied to adjust the BS output power to a value that is sufficiently high to generate a SIR at the UE receiver equal to the target SIR, while limiting the intercell interference.

The test purpose is to verify the ability of the BS to interpret received TPC commands in a correct way and to adjust its output power according to these commands with the specified accuracy.

6.4.2.4 Method of test

6.4.2.4.1 Initial conditions

6.4.2.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.4.2.4.1.~~1~~2 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Disable closed loop power control in the BS under test.

(3) Set the initial parameters of the BS transmitted signal according to table 6.4.

(4) Operate the BS in such a mode that it is able to interpret received TPC commands.

(5) Start BS transmission.

NOTE: The BS tester used for this test must have the ability:

- to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C;
- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.4: Initial parameters of the BS transmitted signal for power control steps test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	1
DPCH power	Minimum
Data content of DPCH	real life (sufficient irregular)

6.4.2.4.1.~~3~~2 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Disable closed loop power control in the BS under test.

(3) Set the initial parameters of the BS transmitted signal according to table 6.4A.

(4) Operate the BS in such a mode that it is able to interpret received TPC commands.

(5) Start BS transmission.

6.4.3 Power control dynamic range

6.4.3.1 Definition and applicability

The power control dynamic range is the difference between the maximum and the minimum transmit output power for a specified reference condition.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.3.2 Minimum Requirements

The DL power control dynamic range shall be greater than or equal to 30 dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.3.1.

6.4.3.3 Test purpose

The test purpose is to verify the ability of the BS to control the power of a single code signal over the specified dynamic range.

6.4.3.4 Method of test

6.4.3.4.1 Initial conditions

6.4.3.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.4.3.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.6.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

NOTE: The BS tester used for this test must have the ability:

- to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C;

- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.6: Parameters of the BS transmitted signal for power control dynamic range test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	1
Data content of DPCH	real life (sufficient irregular)

6.4.3.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.6A.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

6.4.4 Minimum transmit power

6.4.4.1 Definition and applicability

The minimum controlled output power of the BS is when the power control setting is set to a minimum value. This is when the power control indicates a minimum transmit output power is required.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.4.2 Minimum Requirements

The DL minimum transmit power shall be lower than or equal to:

Maximum output power - 30 dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.4.1.

6.4.4.3 Test purpose

The test purpose is to verify the ability of the BS to reduce its output power to a specified value.

6.4.4.4 Method of test

6.4.4.4.1 Initial conditions

6.4.4.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.4.4.4.1.~~2~~1 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.7.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

NOTE: The BS tester used for this test must have the ability:

- to analyze the output signal of the BS under test with respect to thermal power;

- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.7: Parameters of the BS transmitted signal for minimum transmit power test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.4.4.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.7A.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

6.4.5 Primary CCPCH power

6.4.5.1 Definition and applicability

Primary CCPCH power is the transmission power of the Primary Common Control Physical Channel averaged over the transmit timeslot. Primary CCPCH power is signaled on the BCH.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.5.2 Minimum Requirements

The error between the BCH-broadcast value of the Primary CCPCH power and the Primary CCPCH power averaged over the timeslot shall not exceed the values in table 6.8. The error is a function of the total power averaged over the timeslot, Pout, and the manufacturer's rated output power, PRAT.

Table 6.8: Errors between Primary CCPCH power and the broadcast value

Total power in slot, dB	PCCPCH power tolerance
PRAT - 3 < Pout ≤ PRAT + 2	+/- 2,5 dB
PRAT - 6 < P ≤ PRAT - 3	+/- 3,5 dB
PRAT - 13 < P ≤ PRAT - 6	+/- 5 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.5.

6.4.5.3 Test purpose

The power of the Primary CCPCH received by the UE, together with the information on the Primary CCPCH nominal transmit power signaled on the BCH, are used by the UE for path loss estimation and adjustment of its own transmit power. Therefore, deviations of the Primary CCPCH power from its nominal value are transposed by the UE into deviations from the wanted transmit power of the UE.

The test purpose is to verify that the Primary CCPCH power remains within its specified tolerances under normal and extreme conditions.

6.4.5.4 Method of test

6.4.5.4.1 Initial conditions

6.4.5.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.4.5.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester to the antenna connector of the BS under test. The BS tester must have the ability to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C.

(1) Set the parameters of the BS transmitted signal according to table 6.9.

Table 6.9: Parameters of the BS transmitted signal for Primary CCPCH power testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Time slots carrying PCCPCH	TS 0 and TS 8
Number of additional DPCH in TS 0 and TS 8	3
BS output power setting	PRAT
Relative power of PCCPCH	¼ of BS output power
Relative power of each DPCH in TS 0 and TS 8	¼ of BS output power
Data content of DPCH	real life (sufficient irregular)

6.4.5.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test. The BS tester must have the ability to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C.

(2) Set the parameters of the BS transmitted signal according to table 6.9A.

6.5.2 Transmit ON/OFF time mask

6.5.2.1 Definition and applicability

The transmit ON/OFF time mask defines the ramping time allowed for the BS between transmit OFF power and transmit ON power.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.5.2.2 Minimum Requirements

6.5.2.2.1 3,84 Mcps TDD option

The transmit power level versus time should meet the mask specified in figure 6.1.

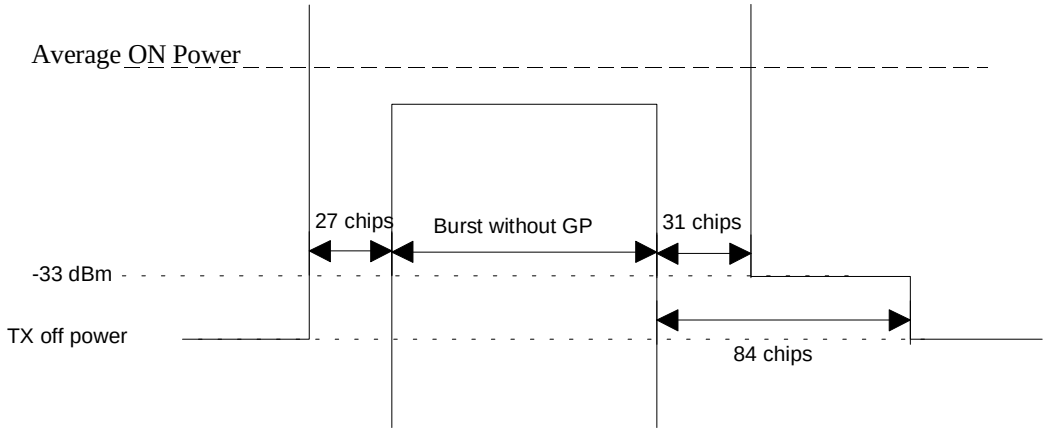

Figure 6.1: Transmit ON/OFF template

The normative reference for this requirement is TS 25.105 [1] subclause 6.5.2.1.1.

6.5.2.2.2 1,28 Mcps TDD option

The transmit power level versus time should meet the mask specified in figure 6.1A.

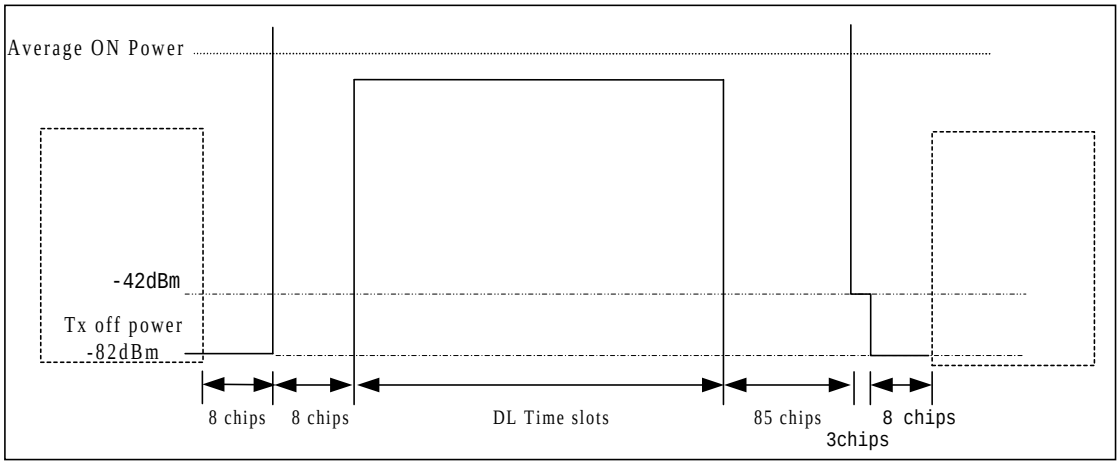

Figure 6.1A: Transmit ON/OFF template for 1,28 Mcps TDD option

The normative reference for this requirement is TS 25.105 [1] subclause 6.5.2.1.2.

6.5.2.3 Test purpose

This test verifies the ability of the BS to reduce its transmit power outside of the active part of the Tx time slot (burst without guard period) to values below specified limits. This ability is needed to minimize the interference for other users receiving on the same frequency.

6.5.2.4 Method of test

6.5.2.4.1 Initial conditions

6.5.2.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.5.2.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the power measuring equipment to the BS antenna connector.

(2) Set the parameters of the transmitted signal according to table 6.11.

Table 6.11: Parameters of the transmitted signal for transmit ON/OFF time mask test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	Real life (sufficient irregular)

6.5.2.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the power measuring equipment to the BS antenna connector.

(2) Set the parameters of the transmitted signal according to table 6.11A.

6.6 Output RF spectrum emissions

6.6.1 Occupied bandwidth

6.6.1.1 Definition and applicability

Occupied bandwidth is a measure of the bandwidth containing 99% of the total integrated power for transmitted spectrum and is centered on the assigned channel frequency.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.6.1.2 Minimum Requirements

6.6.1.2.1 3,84 Mcps TDD option

The occupied bandwidth shall be less than 5 MHz based on a chip rate of 3,84 Mcps.

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.1.1.

6.6.1.2.2 1,28 Mcps TDD option

The occupied bandwidth shall be less than 1,~~.~~6 MHz based on a chip rate of 1,28 Mcps.

The reference for this requirement is TS 25.105 [1] subclause 6.6.1.2.

6.6.1.3 Test purpose

The occupied bandwidth, defined in the Radio Regulations of the International Telecommunication Union ITU, is a useful concept for specifying the spectral properties of a given emission in the simplest possible manner; see also Recommendation ITU-R SM.328-9 [7]. The test purpose is to verify that the emission of the BS does not occupy an excessive bandwidth for the service to be provided and is, therefore, not likely to create interference to other users of the spectrum beyond undue limits.

6.6.1.4 Method of test

6.6.1.4.1 Initial conditions

6.6.1.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.6.1.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.12.

Table 6.12: Parameters of the BS transmitted signal for occupied bandwidth testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	Real life (sufficient irregular)

6.6.1.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.12A.

6.6.2 Out of band emission

Out of band emissions are unwanted emissions immediately outside the channel bandwidth resulting from the modulation process and non-linearity in the transmitter but excluding spurious emissions. This out of band emission requirement is specified both in terms of a spectrum emission mask and adjacent channel power ratio for the transmitter.

6.6.2.1 Spectrum emission mask

6.6.2.1.1 Definition and applicability

6.6.2.1.1.1 3,84 Mcps TDD option

The spectrum emission mask specifies the limit of the transmitter out of band emissions at frequency offsets from the assigned channel frequency of the wanted signal between 2,5 MHz and 12,5 MHz.

The mask defined in subclause 6.6.2.1.2.1 below may be mandatory in certain regions. In other regions this mask may not be applied.

6.6.2.1.1.2 1,28 Mcps TDD option

The spectrum emission mask specifies the limit of the transmitter out of band emissions at frequency offsets from the assigned channel frequency of the wanted signal between 0,8 MHz and 4 MHz.

The mask defined in subclause 6.6.2.1.2.2 below may be mandatory in certain regions. In other regions this mask may not be applied.

6.6.2.1.2 Minimum Requirements

6.6.2.1.2.1 3,84 Mcps TDD option

For regions where this subclause applies, the requirement shall be met by a base station transmitting on a single RF carrier configured in accordance with the manufacturer's specification. Emissions shall not exceed the maximum level specified in tables 6.13 to 6.16 in the frequency range of f_offset from 2,515 MHz to f_offset_{max} from the carrier frequency, where:

f_offset is the separation between the carrier frequency and the centre of the measurement filter

f_offset_{max} is either 12,5 MHz or the offset to the UMTS Tx band edge as defined in subclause 4.2, whichever is the greater.

Table 6.13: Spectrum emission mask values, BS rated output power PRAT ≥ 43 dBm

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
2,515 MHz ≤ f_offset < 2,715 MHz	-14 dBm	30 kHz
2,715 MHz ≤ f_offset < 3,515 MHz	- 14 - 15·(f_offset – 2,715) dBm	30 kHz
3,515 MHz ≤ f_offset < 4,0 MHz	-26 dBm	30 kHz
4,0 MHz ≤ f_offset < 8,0 MHz	-13 dBm	1 MHz
8,0 MHz ≤ f_offset < f_offset_{max}	-13 dBm	1 MHz

Table 6.14: Spectrum emission mask values, BS rated output power 39 ≤ PRAT < 43 dBm

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
2,515 MHz ≤ f_offset < 2,715 MHz	-14 dBm	30 kHz
2,715 MHz ≤ f_offset < 3,515 MHz	-14 - 15·(f_offset – 2,715) dBm	30 kHz
3,515 MHz ≤ f_offset < 4,0 MHz	-26 dBm	30 kHz
4,0 MHz ≤ f_offset < 8,0 MHz	-13 dBm	1 MHz
8,0 MHz ≤ f_offset < f_offset_{max}	P – 56 dBm	1 MHz

Table 6.15: Spectrum emission mask values, BS rated output power 31 ≤ PRAT < 39 dBm

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
2,515 MHz ≤ f_offset < 2,715 MHz	P – 53 dBm	30 kHz
2,715 MHz ≤ f_offset < 3,515 MHz	P – 53 - 15·(f_offset – 2,715) dBm	30 kHz
3,515 MHz ≤ f_offset < 4,0 MHz	P – 65 dBm	30 kHz
4,0 MHz ≤ f_offset < 8,0 MHz	P – 52 dBm	1 MHz
8,0 MHz ≤ f_offset < f_offset_{max}	P – 56 dBm	1 MHz

Table 6.16: Spectrum emission mask values, BS rated output power PRAT < 31 dBm

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
2,515 MHz ≤ f_offset < 2,715 MHz	-22 dBm	30 kHz
2,715 MHz ≤ f_offset < 3,515 MHz	-22 – 15·(f_offset – 2,715) dBm	30 kHz
3,515 MHz ≤ f_offset < 4,0 MHz	-34 dBm	30 kHz
4,0 MHz ≤ f_offset < 8,0 MHz	-21 dBm	1 MHz
8,0 MHz ≤ f_offset < f_offset_{max}	-25 dBm	1 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.1.1.

6.6.2.1.2.2 1,28 Mcps TDD option

For regions where this subclause applies, the requirement shall be met by a base station transmitting on a single RF carrier configured in accordance with the manufacturer's specification. Emissions shall not exceed the maximum level specified in tables 6.13A to 16A in the frequency range of f_offset from 0.815 MHz to f_offset_{max} from the carrier frequency, where:

- f_offset is the separation between the carrier frequency and the centre of the measurement filter
- f_offset_{max} is either 4 MHz or the offset to the UMTS Tx band edge as defined in subclause 4.2, whichever is the greater.

Table 6.13A: Spectrum emission mask values, BS maximum output power P ≥ 43 dBm for 1,28 Mcps TDD

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
0.815MHz ≤ f_offset < 1.015MHz	-14 dBm	30 kHz
1.015MHz ≤ f_offset < 1.815MHz	- 14 - 15·(f_offset – 1.015) dBm	30 kHz
1.815MHz ≤ f_offset < 2.3MHz	-28 dBm	30 kHz
2.3MHz ≤ f_offset < f_offset_{max}	-13 dBm	1 MHz

Table 6.14A: Spectrum emission mask values, BS maximum output power 39 ≤ P < 43 dBm for 1,28 Mcps TDD

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
0.815MHz ≤ f_offset < 1.015MHz	-14 dBm	30 kHz
1.015MHz ≤ f_offset < 1.815MHz	-14 - 15·(f_offset – 1.015) dBm	30 kHz
1.815MHz ≤ f_offset < 2.415MHz	-28 dBm	30 kHz
2.415MHz ≤ f_offset < 2.9MHz	P-71 dBm	30 kHz
2.9MHz ≤ f_offset < f_offset_{max}	P - 56 dBm	1 MHz

Table 6.15A: Spectrum emission mask values, BS maximum output power 31 ≤ P < 39 dBm for 1,28 Mcps TDD

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
0.815MHz ≤ f_offset < 1.015MHz	P - 53 dBm	30 kHz
1.015MHz ≤ f_offset < 1.815MHz	P - 53 - 15·(f_offset – 1.015) dBm	30 kHz
1.815MHz ≤ f_offset < 2.415MHz	P - 67 dBm	30 kHz
2.415MHz ≤ f_offset < 2.9MHz	P - 71 dBm	30 kHz
2.9MHz ≤ f_offset < f_offset_{max}	P - 56 dBm	1 MHz

Table 6.16A: Spectrum emission mask values, BS maximum output power P < 31 dBm for 1,28 Mcps TDD

Frequency offset of measurement filter centre frequency, f_offset	Maximum level	Measurement bandwidth
0.815MHz ≤ f_offset < 1.015MHz	-22 dBm	30 kHz
1.015MHz ≤ f_offset < 1.815MHz	-22 - 15·(f_offset – 1.015) dBm	30 kHz
1.815MHz ≤ f_offset < 2.415MHz	-36 dBm	30 kHz
2.415MHz ≤ f_offset < 2.9MHz	-40 dBm	30 kHz
2.9MHz ≤ f_offset < f_offset_{max}	-25 dBm	1 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.1.2.

6.6.2.1.3 Test purpose

The test purpose is to verify that the BS out of band emissions do not result in undue interference to any other system (wideband, narrowband) operating at frequencies close to the assigned channel bandwidth of the wanted signal.

This test is independent of the characteristics of possible victim systems and, therefore, complements the tests on occupied bandwidth in 6.6.1 (verifying the spectral concentration of the BS Tx emissions) and on ACLR in 6.6.2.2 (simulating the perception of other UTRA receivers).

6.6.2.1.4 Method of test

6.6.2.1.4.1 Initial conditions

6.6.2.1.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.6.2.1.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.17.

Table 6.17: Parameters of the BS transmitted signal for spectrum emission mask testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.6.2.1.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.17A.

6.6.2.2 Adjacent Channel Leakage power Ratio (ACLR)

6.6.2.2.1 Definition and applicability

Adjacent Channel Leakage power Ratio (ACLR) is the ratio of the transmitted power to the power measured in an adjacent channel. Both the transmitted and the adjacent channel power are measured through a matched filter (root raised cosine and roll-off 0,22) with a noise power bandwidth equal to the chip rate. The requirements shall apply for all configurations of BS (single carrier or multi-carrier), and for all operating modes foreseen by the manufacturer's specification.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.6.2.2.2 Minimum Requirements

6.6.2.2.2.1 Minimum requirement

6.6.2.2.2.1.1 3,84 Mcps TDD option

The ACLR shall be equal to or greater than the limits given in table 6.22.

Table 6.22: BS ACLR limits

BS adjacent channel offset	ACLR limit
± 5 MHz	45 dB
± 10 MHz	55 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.1.1.

6.6.2.2.2.1.2 1,28 Mcps TDD option

The ACLR shall be equal to or greater than the limits given in Table 6.22A.

Table 6.22A: BS ACLR limits for 1,28 Mcps TDD

BS adjacent channel offset	ACLR limit
± 1,6 MHz	40 dB
± 3,2 MHz	50 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.1.2.

6.6.2.2.2.2 Requirement in case of operation in proximity to TDD BS or FDD BS operating on an adjacent frequency

6.6.2.2.2.2.1 3,84 Mcps TDD option

In case the equipment is operated in proximity to another TDD BS or FDD BS on an adjacent frequency, the ACLR shall be equal to or greater than the value specified in table 6.23.

Table 6.23: BS ACLR limits in case of operation in proximity

BS adjacent channel offset	ACLR limit
± 5 MHz	70 dB
± 10 MHz	70 dB

The requirement is based on the assumption that the coupling loss between the base stations is at least 84dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.2.1.

NOTE: The necessary dynamic range to very the conformance requirements specified in table 6.23 is at the limits of the capability of state-of-art measuring equipment.

6.6.2.2.2.2 1,28 Mcps TDD option

In case the equipment is operated in proximity to another TDD BS or FDD BS and both BSs operating on an adjacent frequency band , the requirement is specified in terms of power level of the transmitting BS. This requirement is valid for co-existence with non-frame and non-switching point synchronised systems operating on the closest used carrier. The interference power level shall not exceed the limit in Table 6.23A.

Table 6.23A: BS ACLR in case of operation in proximity for 1,28 Mcps TDD

Center Frequency for Measurement	Maximum Level of the interference power (in case of multiple antennas the interference powers shall be summed at all antenna connectors)	Measurement Bandwidth
Closest used carrier of the victim receiver: Either FDD carrier Or 3,84 Mcps TDD carrier Or 1,28 Mcps TDD carrier	-36 dBm	chip rate of the victim receiver: In case of FDD: 3,84 MHz In case of 3,84 Mcps TDD: 3,84 MHz In case of 1,28 Mcps TDD: 1,28 MHz

The closest used carrier with respect to the regarded carrier of one system is defined by

a minimum difference in centre frequency between the regarded carrier and the carriers used in the other system and the chip rate of the other system.

If the actual allowed interference level $P_{int, allowed, actual}$ at the victim receiver is higher than –106dBm, this requirement may be relaxed by the amount $P_{int, allowed, actual} - (-106dBm)$.

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.2.2.

6.6.2.2.3 Requirement in case of co-siting with TDD BS or FDD BS operating on an adjacent frequency

6.6.2.2.3.1 3,84 Mcps TDD option

In case the equipment is co-sited to another TDD BS or FDD BS operating on an adjacent frequency, the ACLR is specified in terms of the absolute transmit power level of the BS measured in the adjacent channel. The maximum power level shall not exceed the limit in table 6.24.

Table 6.24: BS ACLR limits in case of co-siting

BS adjacent channel offset	Maximum Level	Measurement Bandwidth
± 5 MHz	-80 dBm	3.84 MHz
± 10 MHz	-80 dBm	3.84 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.3.1.

NOTE: The necessary dynamic range of the measuring equipment to verify the conformance requirements specified in table 6.24 is dependent on the BS output power. If the BS output power is larger than –10 dBm, the necessary dynamic range is beyond the capability of state-of-the-art measuring equipment; direct verification of the conformance requirements is not feasible. Alternatively, indirect measurement methods need to be defined.

6.6.2.2.2.3.2 1,28 Mcps TDD option

In case the equipment is co-sited to another TDD BS or FDD BS and both BSs operating on an adjacent frequency band, the requirement is specified in terms of power level of the transmitting BS. This requirement is valid for co-existence with a non-frame and non-switching point synchronised systems operating on closest used carrier. The interference power level shall not exceed the limit in Table 6.24A.

Table 6.24A : BS ACLR in case of co-siting for 1,28 Mcps TDD

Center Frequency for Measurement	Maximum Level of the interference power (in case of multiple antennas the interference powers shall be summed at all antenna connectors)	Measurement Bandwidth
Closest used carrier of the victim receiver: Either FDD carrier Or 3,84 Mcps TDD carrier Or 1,28 Mcps TDD carrier	-76 dBm	chip rate of the victim receiver: In case of FDD: 3.84 MHz In case of 3,84 Mcps TDD: 3,84 MHz In case of 1,28 Mcps TDD: 1,28 MHz

The closest used carrier with respect to the regarded carrier of one system is defined by:

a minimum difference in centre frequency between the regarded carrier and the carriers used in the other system and the chip rate of the other system.

If the actual MCL_{actual} is higher than 30dB, this requirement may be relaxed by the amount MCL_{actual} – 30dB.

If the actual allowed interference level $P_{int, allowed, actual}$ at the victim receiver is higher than –106dBm, this requirement may be relaxed by the amount $P_{int, allowed, actual}$ – (-106dBm).

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.3.2.

6.6.2.2.3 Test purpose

The test purpose is to verify the ability of the BS to limit the interference produced by the transmitted signal to other UTRA receivers operating at the first or second adjacent RF channel.

6.6.2.2.4 Method of test

6.6.2.2.4.1 Initial conditions

6.6.2.2.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.6.2.2.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.25.

Table 6.25: Parameters of the BS transmitted signal for ACLR testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	Real life (sufficient irregular)

6.6.2.2.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.25A.

6.6.3 Spurious emissions

6.6.3.1 Definition and applicability

Spurious emissions are emissions which are caused by unwanted transmitter effects such as harmonics emission, parasitic emission, intermodulation products and frequency conversion products, but exclude out of band emissions. This is measured at the base station RF output port.

Unless otherwise stated, all requirements are measured as mean power.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.6.3.2 Minimum Requirements

6.6.3.2.1 Mandatory requirements

The requirements of either subclause 6.6.3.2.1.1 or subclause 6.6.3.2.1.2 shall apply whatever the type of transmitter considered (single carrier or multi-carrier). It applies for all transmission modes foreseen by the manufacturer.

6.6.3.2.1.1 Spurious emissions (Category A)

The following requirements shall be met in cases where Category A limits for spurious emissions, as defined in ITU-R Recommendation SM.329-8 [6], are applied.

6.6.3.2.1.1.1 3,84 Mcps TDD option

Either requirement applies at frequencies within the specified frequency ranges which are more than 12,5 MHz under the first carrier frequency used or more than 12,5 MHz above the last carrier frequency used.

The power of any spurious emission shall not exceed the maximum level given in Table 6.29.

Table 6.29: BS Mandatory spurious emissions limits, Category A

Band	Maximum level	Measurement bandwidth	Note
9 kHz – 150 kHz	-13 dBm	1 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
150 kHz – 30 MHz		10 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
30 MHz – 1 GHz		100 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
1 GHz – 12,75 GHz		1 MHz	Upper frequency as in ITU-R SM.329-8, s2.5 table 1

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.1.1.1.1.

6.6.3.2.1.1.2 1,28 Mcps TDD option

Either requirement applies at frequencies within the specified frequency ranges which are more than 4 MHz under the first carrier frequency used or more than 4 MHz above the last carrier frequency used.

The power of any spurious emission shall not exceed the maximum level given in Table 6.29A.

Table 6.29A: BS Mandatory spurious emissions limits, Category A

Band	Maximum level	Measurement bandwidth	Note
9 kHz – 150 kHz	-13 dBm	1 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
150 kHz – 30 MHz		10 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
30 MHz – 1 GHz		100 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
1 GHz – 12,75 GHz		1 MHz	Upper frequency as in ITU-R SM.329-8, s2.5 table 1

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.1.1.1.2.

6.6.3.2.1.2 Spurious emissions (Category B)

The following requirements shall be met in cases where Category B limits for spurious emissions, as defined in ITU-R Recommendation SM.329-8 [6], are applied.

6.6.3.2.1.2.1 3,84 Mcps TDD option

Either requirement applies at frequencies within the specified frequency ranges which are more than 12,5 MHz under the first carrier frequency used or more than 12,5 MHz above the last carrier frequency used.

The power of any spurious emission shall not exceed the maximum levels given in Table 6.30.

Table 6.30: BS Mandatory spurious emissions limits, Category B

Band	Maximum level	Measurement bandwidth	Note
9 kHz – 150 kHz	-36 dBm	1 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
150 kHz – 30 MHz	-36 dBm	10 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
30 MHz – 1 GHz	-36 dBm	100 kHz	Bandwidth as in ITU-R SM.329-8, s4.1
1 GHz – Fc1 - 60 MHz or Fl - 10 MHz *whichever is the higher*	-30 dBm	1 MHz	Bandwidth as in ITU-R SM.329-8, s4.1
Fc1 - 60 MHz or Fl - 10 MHz *whichever is the higher* – Fc1 - 50 MHz or Fl -10 MHz *whichever is the higher*	-25 dBm	1 MHz	Specification in accordance with ITU-R SM.329-8, s4.3 and Annex 7
Fc1 - 50 MHz or Fl -10 MHz *whichever is the higher* – Fc2 + 50 MHz or Fu +10 MHz *whichever is the lower*	-15 dBm	1 MHz	Specification in accordance with ITU-R SM.329-8, s4.3 and Annex 7
Fc2 + 50 MHz or Fu + 10 MHz *whichever is the lower* – Fc2 + 60 MHz or Fu + 10 MHz *whichever is the lower*	-25 dBm	1 MHz	Specification in accordance with ITU-R SM.329-8, s4.3 and Annex 7
Fc2 + 60 MHz or Fu + 10 MHz *whichever is the lower* – 12,75 GHz	-30 dBm	1 MHz	Bandwidth as in ITU-R SM.329-8, s4.1. Upper frequency as in ITU-R SM.329-8, s2.5 table 1

Fc1: Center frequency of emission of the first carrier transmitted by the BS

Fc2: Center frequency of emission of the last carrier transmitted by the BS

Fl : Lower frequency of the band in which TDD operates

Fu : Upper frequency of the band in which TDD operates

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.1.2.1.1.

6.6.3.2.1.2.2 1,28 Mcps TDD option

Either requirement applies at frequencies within the specified frequency ranges which are more than 4 MHz under the first carrier frequency used or more than 4 MHz above the last carrier frequency used.

The power of any spurious emission shall not exceed the maximum levels given in Table 6.30A.

Table 6.30A: BS Mandatory spurious emissions limits, Category B for 1,28 Mcps TDD

Band	Maximum Level	Measurement Bandwidth	Note
9kHz – 150kHz	-36 dBm	1 kHz	Bandwidth as in ITU SM.329-8, s4.1
150kHz – 30MHz	- 36 dBm	10 kHz	Bandwidth as in ITU SM.329-8, s4.1
30MHz – 1GHz	-36 dBm	100 kHz	Bandwidth as in ITU SM.329-8, s4.1
1GHz ↔ Fc1-19,2 MHz or Fl –3,2 MHz *whichever is the higher*	-30 dBm	1 MHz	Bandwidth as in ITU SM.329-8, s4.1
Fc1 – 19,2 MHz or Fl - 3,2MHz *whichever is the higher* ↔ Fc1 - 16 MHz or Fl –3,2 MHz *whichever is the higher*	-25 dBm	1 MHz	Specification in accordance with ITU-R SM.329-8, s4.1
Fc1 - 16 MHz or Fl –3,2 MHz *whichever is the higher* ↔ Fc2 + 16 MHz or Fu +3,2 MHz *whichever is the lower*	-15 dBm	1 MHz	Specification in accordance with ITU-R SM.329-8, s4.1
Fc2 + 16 MHz or Fu + 3,2 MHz *whichever is the lower* ↔ Fc2 +19,2 MHz or Fu + 3,2 MHz *whichever is the lower*	-25 dBm	1 MHz	Specification in accordance with ITU-R SM.329-8, s4.1
Fc2 + 19,2 MHz or Fu +3,2 MHz *whichever is the lower* ↔ 12,75 GHz	-30 dBm	1 MHz	Bandwidth as in ITU-R SM.329-8, s4.1. Upper frequency as in ITU-R SM.329-8, s2.5 table 1

Fc1: Center frequency of emission of the first carrier transmitted by the BS

Fc2: Center frequency of emission of the last carrier transmitted by the BS

Fl : Lower frequency of the band in which TDD operates

Fu : Upper frequency of the band in which TDD operates

The reference for this requirement is TS 25.105 subclause 6.6.3.1.2.1.2.

6.6.3.2.2 Co-existence with GSM

6.6.3.2.2.1 Operation in the same geographic area

This requirement may be applied for the protection of GSM 900 MS in geographic areas in which both GSM 900 and UTRA are deployed.

The power of any spurious emission shall not exceed the maximum level given in Table 6.31.

Table 6.31: BS Spurious emissions limits for BS in geographic coverage area of GSM 900 MS receiver

Band	Maximum level	Measurement bandwidth	Note
921 MHz – 960 MHz	-57 dBm	100 kHz	

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.2.1.1.

6.6.3.2.2.2 Co-located base stations

This requirement may be applied for the protection of GSM 900 BTS receivers when GSM 900 BTS and UTRA BS are co-located.

The power of any spurious emission shall not exceed the maximum level given in table 6.32.

Table 6.32: BS Spurious emissions limits for protection of the GSM 900 BTS receiver

Band	Maximum level	Measurement bandwidth	Note
876 MHz – 915 MHz	–98 dBm	100 kHz	

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.2.2.1.

6.6.3.2.3 Co-existence with DCS 1800

6.6.3.2.3.1 Operation in the same geographic area

This requirement may be applied for the protection of DCS 1800 MS in geographic areas in which both DCS 1800 and UTRA are deployed.

The power of any spurious emission shall not exceed the maximum level given in table 6.33.

Table 6.33: BS Spurious emissions limits for BS in geographic coverage area of DCS 1800 MS receiver

Band	Maximum level	Measurement bandwidth	Note
1805 MHz – 1880 MHz	-47 dBm	100 kHz	

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.3.1.1.

6.6.3.2.3.2 Co-located base stations

This requirement may be applied for the protection of DCS 1800 BTS receivers when DCS 1800 BTS and UTRA BS are co-located.

The power of any spurious emission shall not exceed the maximum level given in table 6.34.

Table 6.34: BS Spurious emissions limits for BS co-located with DCS 1800 BTS

Band	Maximum level	Measurement bandwidth	Note
1710 MHz – 1785 MHz	-98 dBm	100 kHz	

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.3.~~3~~2.1.

6.6.3.2.4 Co-existence with UTRA FDD

6.6.3.2.4.1 Operation in the same geographic area

This requirement may be applied to geographic areas in which both UTRA TDD and UTRA FDD are deployed.

The power of any spurious emission shall not exceed the maximum level given in table 6.35.

Table 6.35: BS Spurious emissions limits for BS in geographic coverage area of UTRA FDD

Band	Maximum Level	Measurement Bandwidth	Note
1920 – 1980 MHz	-32 dBm	1 MHz	
2110 – 2170 MHz	-52 dBm	1 MHz	

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.4.1.1.

6.6.3.2.4.2 Co-located base stations

This requirement may be applied for the protection of UTRA FDD BS receivers when UTRA TDD BS and UTRA FDD BS are co-located.

The power of any spurious emission shall not exceed the maximum level given in table 6.36.

Table 6.36: BS Spurious emissions limits for BS co-located with UTRA FDD

Band	Maximum Level	Measurement Bandwidth	Note
1920 – 1980 MHz	-86 dBm	1 MHz	
2110 – 2170 MHz	-52 dBm	1 MHz	

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.3.4.2.1.

6.6.3.3 Test purpose

6.6.3.3.1 3,84 Mcps TDD option

The test purpose is to verify the ability of the BS to limit the interference caused by unwanted transmitter effects to other systems operating at frequencies which are more than 12,5 MHz away from of the UTRA band used.

6.6.3.3.2 1,28 Mcps TDD option

The test purpose is to verify the ability of the BS to limit the interference caused by unwanted transmitter effects to other systems operating at frequencies which are more than 4 MHz away from of the UTRA band used.

6.6.3.4 Method of test

6.6.3.4.1 Initial conditions

6.6.3.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.6.3.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.37.

Table 6.37: Parameters of the BS transmitted signal for spurious emissions testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.6.3.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.37A.

6.7 Transmit intermodulation

6.7.1 Definition and applicability

The transmit intermodulation performance is a measure of the capability of the transmitter to inhibit the generation of signals in its non linear elements caused by presence of the wanted signal and an interfering signal reaching the transmitter via the antenna.

The transmit intermodulation level is the power of the intermodulation products when a CDMA modulated interference signal is injected into the antenna connector at a level of 30 dB lower than that of the subject signal.

6.7.1.1 3,84 Mcps TDD option

The frequency of the interference signal shall be ±5 MHz, ±10 MHz and ±15 MHz offset from the subject signal.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.7.1.2 1,28 Mcps TDD option

The frequency of the interference signal shall be ±1,6 MHz, ±3,2 MHz and ±4,8 MHz offset from the subject signal.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.7.2 Minimum Requirements

The transmit intermodulation level shall not exceed the out of band or the spurious emission requirements of subclause 6.6.2 and 6.6.3, respectively.

The normative reference for this requirement is TS 25.105 [1] subclause 6.7.1.

6.7.3 Test purpose

The test purpose is to verify the ability of the BS transmitter to restrict the generation of intermodulation products in its non linear elements caused by presence of the wanted signal and an interfering signal reaching the transmitter via the antenna to below specified levels.

6.7.4 Method of test

6.7.4.1 Initial conditions

6.7.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.7.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment, the BS under test and the CDMA signal generator as shown in figure 6.2.

(2) Set the parameters of the BS transmitted signal according to table 6.38.

(3) Configure the CDMA signal generator to produce an interference signal with a level of 30 dB lower than that of the BS transmitted signal. The interference signal shall be like-modulated as the BS transmitted signal, and the

active time slots of both signals shall be synchronized. The frequency of the interference signal shall be ±5 MHz, ±10 MHz and ±15 MHz offset from the BS transmitted signal.

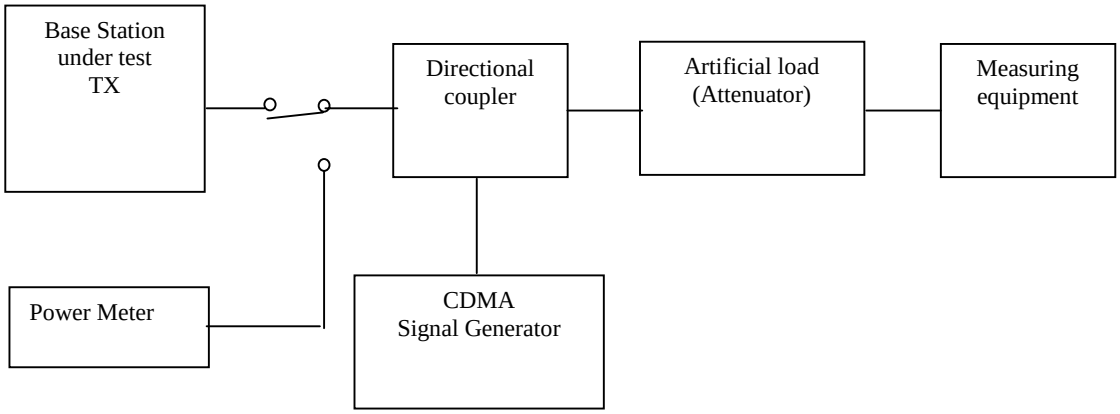

Figure 6.2: Measuring setup for Base Station transmit intermodulation testing

Table 6.38: Parameters of the BS transmitted signal for transmit intermodulation testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is odd; receive, if i is even.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.7.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the measuring equipment, the BS under test and the CDMA signal generator as shown in figure 6.2A.

(2) Set the parameters of the BS transmitted signal according to table 6.38A.

(3) Configure the CDMA signal generator to produce an interference signal with a level of 30 dB lower than that of the BS transmitted signal. The interference signal shall be like-modulated as the BS transmitted signal, and the active time slots of both signals shall be synchronized. The frequency of the interference signal shall be ±1,6 MHz, ±3,2 MHz and ±4,8 MHz offset from the BS transmitted signal.

6.8 Transmit Modulation

6.8.1 Modulation accuracy

6.8.1.1 Definition and applicability

The Error Vector Magnitude is a measure of the difference between the reference waveform and the measured waveform. This difference is called the error vector. Both waveforms pass through a matched Root Raised Cosine filter with bandwidth corresponding to the considered chip rate and roll-off α =0,22. Both waveforms are then further modified by selecting the frequency, absolute phase, absolute amplitude and chip clock timing so as to minimise the error vector. The EVM result is defined as the square root of the ratio of the mean error vector power to the mean reference power expressed as a %. The measurement interval is one timeslot. The requirement is valid over the total power dynamic range as specified in 25.105 subclause 6.4.3. See Annex C of this specification for further details.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

NOTE: The theoretical modulated waveform shall be calculated on the basis that the transmit pulse shaping filter is a root-raised cosine (RRC) with roll-off α =0,22 in the frequency domain. The impulse response of the chip impulse filter $RC_0(t)$ is

$$RC_0(t) = \frac{\sin\left(\pi \frac{t}{T_C}(1-\alpha)\right) + 4\alpha \frac{t}{T_C}\cos\left(\pi \frac{t}{T_C}(1+\alpha)\right)}{\pi \frac{t}{T_C}\left(1-\left(4\alpha \frac{t}{T_C}\right)^2\right)}$$

Where the roll-off factor α = 0,22 and T_C is the chip duration

6.8.1.2 Minimum Requirements

The error vector magnitude (EVM) shall not exceed 12,5 %. The requirement is valid over the total power dynamic range as specified in subclause 6.4.3 of TS 25.105.

The normative reference for this requirement is TS 25.105 [1] subclause 6.8.2.1.

6.8.1.3 Test purpose

The test purpose is to verify the ability of the BS transmitter to generate a sufficient precise waveform and thus to enable the UE receiver to achieve the specified error performance.

6.8.1.4 Method of test

6.8.1.4.1 Initial conditions

6.8.1.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.8.1.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.39.

Table 6.39: Parameters of the BS transmitted signal for modulation accuracy testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	1
BS power setting	PRAT
Data content of DPCH	real life (sufficient irregular)

6.8.1.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.39A.

6.8.2 Peak code domain error

6.8.2.1 Definition and applicability

The code domain error is computed by projecting the error vector power onto the code domain at a specific spreading factor. The error power for each code is defined as the ratio to the mean power of the reference waveform expressed in dB. And the Peak Code Domain Error is defined as the maximum value for Code Domain Error. The measurement interval is one timeslot.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.8.2.2 Minimum Requirements

The peak code domain error shall not exceed -28 dB at spreading factor 16.

The normative reference for this requirement is TS 25.105 [1] subclause 6.8.3.1.

6.8.2.3 Test purpose

The test purpose is to verify the ability of the BS transmitter to limit crosstalk among codes and thus to enable the UE receiver to achieve the specified error performance.

6.8.2.4 Method of test

6.8.2.4.1 Initial conditions

6.8.2.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

6.8.2.4.1.~~2~~1 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.40.

Table 6.40: Parameters of the BS transmitted signal

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)
Spreading factor	16

6.8.2.4.1.~~3~~2 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.40A.

7.2 Reference sensitivity level

7.2.1 Definition and applicability

The reference sensitivity is the minimum receiver input power measured at the antenna connector at which the BER does not exceed the specific value.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.2.2 Minimum Requirements

7.2.2.1 3,84 Mcps TDD option

For the measurement channel specified in Annex A.2.1, the reference sensitivity level and performance of the BS shall be as specified in table 7.1 below.

Table 7.1: BS reference sensitivity level

Data rate	BS reference sensitivity level (dBm)	BER
12,2 kbps	-109 dBm	BER shall not exceed 0,001

The normative reference for this requirement is TS 25.105 [1] subclause 7.2.1.1.

7.2.2.2 1,28 Mcps option

For the measurement channel specified in Annex A.2.1.2, the reference sensitivity level and performance of the BS shall be as specified in table 7.1A below.

Table 7.1A: BS reference sensitivity levels (1,28 Mcps option)

Data rate	BS reference sensitivity level (dBm)	BER
12,2 kbps	-110 dBm	BER shall not exceed 0,001

The normative reference for this requirement is TS 25.105 [1] subclause 7.2.1.2.

7.2.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed single-code test signal of minimum input power under defined conditions (no interference, no multipath propagation) with a BER not exceeding a specified limit. This test is also used as a reference case for other tests to allow the assessment of degradations due to various sources of interference.

7.2.4 Method of test

7.2.4.1 Initial conditions

7.2.4.1.1 General test requirements

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

The following additional test shall be performed:

On each of B, M and T, the test shall be performed under extreme power supply as defined in subclause 5.9.4.

NOTE: Tests under extreme power supply also test extreme temperature.

7.2.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

~~The following additional test shall be performed:~~

~~On each of B, M and T, the test shall be performed under extreme power supply as defined in subclause 5.9.4.~~

~~NOTE: Tests under extreme power supply also test extreme temperature.~~

~~50~~

(1) Connect the BS tester (UE simulator) to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12.2 kbps) defined in Annex A.2.1.

(4) The level of the BS tester output signal measured at the BS antenna connector shall be adjusted to the Test Requirement for the BS reference sensitivity level specified in table 7.2.

7.2.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester (UE simulator) to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12.2 kbps) defined in Annex A.2.1.

(4) The level of BS tester output signal measured at the BS antenna connector shall be adjusted to –110 dBm.

7.3 Dynamic range

7.3.1 Definition and applicability

Receiver dynamic range is the receiver ability to handle a rise of interference in the reception frequency channel. The receiver shall fulfil a specified BER requirement for a specified sensitivity degradation of the wanted signal in the presence of an interfering AWGN signal in the same reception frequency channel.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.3.2 Minimum Requirements

7.3.2.1 3,84 Mcps TDD option

The BER shall not exceed 0,001 for the parameters specified in table 7.3.

Table 7.3: Dynamic Range

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	<REFSENS> + 30 dB	dBm
Interfering AWGN signal	-73	dBm/3,84 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 7.3.1.1.

7.3.2.2 1,28 Mcps TDD option

The BER shall not exceed 0,001 for the parameters specified in table 7.3A.

Table 7.3A: Dynamic Range for 1,28 Mcps TDD

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	<REFSENS> + 30 dB	dBm
Interfering AWGN signal	-76	dBm/1,28 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 7.3.1.2.

7.3.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed single-code test signal of maximum input power under defined conditions (specified interference, no multipath) with a BER not exceeding a specified limit.

7.3.4 Method of test

7.3.4.1 Initial conditions

7.3.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

7.3.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester (UE simulator), generating the wanted signal, and a band-limited white noise source, generating the interfering AWGN signal, to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12,2 kbps) defined in Annex A.2.1.

(4) The level of the BS tester output signal measured at the BS antenna connector shall be adjusted as specified in table 7.4.

(5) The power spectral density of the band-limited white noise source measured at the BS antenna connector shall be adjusted as specified in table 7.4. The minimum bandwidth of the white noise source shall be 1,5 times the chip rate (5,76 MHz for a chip rate of 3,84 MHz).

7.3.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester (UE simulator), generating the wanted signal, and a band-limited white noise source, generating the interfering AWGN signal, to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12~~,~~2 kbps) defined in Annex A.2.1.

(4) The level of the BS tester output signal measured at the BS antenna connector shall be adjusted as specified in table 7.3A.

(5) The power spectral density of the band-limited white noise source measured at the BS antenna connector shall be adjusted as specified in table 7.3A. The minimum bandwidth of the white noise source shall be 1,5 times the chip rate (2,4 MHz for a chip rate of 1,28 MHz).

7.4 Adjacent Channel Selectivity (ACS)

7.4.1 Definition and applicability

Adjacent channel selectivity (ACS) is a measure of the receiver ability to receive a wanted signal at its assigned channel frequency in the presence of an adjacent channel signal at a given frequency offset from the center frequency of the assigned channel.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.4.2 Minimum Requirements

7.4.2.1 3,84 Mcps TDD option

The BER, measured on the wanted signal in the presence of an interfering signal, shall not exceed 0,001 for the parameters specified in table 7.5.

Table 7.5: Parameters of the wanted signal and the interfering signal for ACS testing

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	Reference sensitivity level + 6 dB	dBm
Interfering signal	-52	dBm
Fuw (modulated)	5	MHz
NOTE: Fuw is the frequency offset of the unwanted interfering signal from the assigned channel frequency of the wanted signal.		

The normative reference for this requirement is TS 25.105 [1] subclause 7.4.1.1.

7.4.2.2 1,28 Mcps TDD option

The BER, measured on the wanted signal in the presence of an interfering signal, shall not exceed 0,001 for the parameters specified in table 7.5A.

Table 7.5A: Parameters of the wanted signal and the interfering signal for ACS testing for 1,28 Mcps TDD

Parameter	Level	Unit
Data rate	12,2	kbit/s
Wanted signal	Reference sensitivity level + 6 dB	dBm
Interfering signal	-55	dBm
Fuw (modulated)	1,6	MHz
NOTE: Fuw is the frequency offset of the unwanted interfering signal from the assigned channel frequency of the wanted signal.		

The normative reference for this requirement is TS 25.105 [1] subclause 7.4.1.2.

7.4.3 Test purpose

The test purpose is to verify the ability of the BS receiver filter to sufficiently suppress interfering signals in the channels adjacent to the wanted channel.

7.4.4 Method of test

7.4.4.1 Initial conditions

7.4.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

7.4.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect an UE simulator operating at the assigned channel frequency of the wanted signal and a signal generator used to produce the interfering signal in the adjacent channel to the antenna connector of one Rx port.

(2) Terminate or disable any other Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12,2 kbps) defined in Annex A.2.1. The level of the UE simulator signal measured at the BS antenna connector shall be adjusted to the value specified in table 7.5.

(4) Set the signal generator to produce an interfering signal that is equivalent to a continuous wideband CDMA signal with one code of chip frequency 3,84 Mchip/s, filtered by an RRC transmit pulse-shaping filter with roll-off α = 0,22. The level of the interfering signal measured at the BS antenna connector shall be adjusted to the value specified in table 7.5.

7.4.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect an UE simulator operating at the assigned channel frequency of the wanted signal and a signal generator used to produce the interfering signal in the adjacent channel to the antenna connector of one Rx port.

(2) Terminate or disable any other Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12,~~.~~2 kbps) defined in Annex A.2.1. The level of the UE simulator signal measured at the BS antenna connector shall be adjusted to the value specified in table 7.5A.

(4) Set the signal generator to produce an interfering signal that is equivalent to a continuous wideband CDMA signal with one code of chip frequency 1,28 Mchip/s, filtered by an RRC transmit pulse-shaping filter with roll-off α = 0,22. The level of the interfering signal measured at the BS antenna connector shall be adjusted to the value specified in table 7.5A.

7.5 Blocking characteristics

7.5.1 Definition and applicability

7.5.1.1 3,84 Mcps TDD option

The blocking characteristics is a measure of the receiver ability to receive a wanted signal at its assigned channel frequency in the presence of an unwanted interferer on frequencies other than those of the adjacent channels. The blocking performance requirements applies to interfering signals with center frequency within the ranges specified in tables 7.6, 7.7, 7.8, 7.9 and 7.10 respectively, using a 1 MHz step size.

The requirements in tables 7.6, 7.7 or 7.8 apply to base stations intended for general-purpose applications, depending on which frequency band is used. The additional requirements in Tables 7.9 and 7.10 may be applied for the protection of TDD BS receivers when GSM900 and/or DCS1800 BTS are co-located with UTRA TDD BS.

7.5.1.2 1,28 Mcps TDD option

The blocking characteristics is a measure of the receiver ability to receive a wanted signal at its assigned channel frequency in the presence of an unwanted interferer on frequencies other than those of the adjacent channels. The blocking performance requirement applies to interfering signals with center frequency within the ranges specified in tables 7.6A, 7.7A, 7.8A, 7.9A and 7.10A respectively, using a 1 MHz step size.

The requirements in Table 7.6A, 7.7A or 7.8A apply to base stations intended for general-purpose applications, depending on which frequency band is used. The additional requirements in Tables 7.9A and 7.10A may be applied for the protection of TDD BS receivers when GSM900 and/or DCS1800 BTS are co-located with UTRA TDD BS.

7.5.2 Minimum Requirements

7.5.2.1 3,84 Mcps TDD option

7.5.2.1.1 General requirements

The static reference performance as specified in clause 7.2 shall be met with a wanted and an interfering signal coupled to the BS antenna input using the parameters specified in tables 7.6, 7.7 and or 7.8 respectively.

Table 7.6: Blocking requirements for operating bands defined in subclause 4.2 a)

Center frequency of interfering signal	Interfering signal level	Wanted signal level	Minimum offset of interfering signal	Type of interfering signal
1900 – 1920 MHz, 2010 – 2025 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1880 – 1900 MHz, 1990 – 2010 MHz, 2025 – 2045 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1920 – 1980 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1 - 1880 MHz, 1980 – 1990 MHz, 2045 – 12750 MHz	-15 dBm	<REFSENS> + 6 dB	—	CW carrier

Table 7.7: Blocking requirements for operating bands defined in subclause 4.2 b)

Center frequency of interfering signal	Interfering signal level	Wanted signal level	Minimum offset of interfering signal	Type of interfering signal
1850 – 1990 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1830 – 1850 MHz, 1990 – 2010 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1 – 1830 MHz, 2010 – 12750 MHz	-15 dBm	<REFSENS> + 6 dB	—	CW carrier

Table 7.8: Blocking requirements for operating bands defined in subclause 4.2 c)

Center frequency of interfering signal	Interfering signal level	Wanted signal level	Minimum offset of interfering signal	Type of interfering signal
1910 – 1930 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1890 – 1910 MHz, 1930 – 1950 MHz	-40 dBm	<REFSENS> + 6 dB	10 MHz	WCDMA signal with one code
1 – 1890 MHz, 1950 – 12750 MHz	-15 dBm	<REFSENS> + 6 dB	—	CW carrier

The normative reference for this requirement is TS 25.105 [1] subclause 7.5.0.1.

7.5.2.1.2 Co-location with GSM900 and/or DCS 1800

This additional blocking requirement may be applied for the protection of TDD BS receivers when GSM900 and/or DCS1800 BTS are co-located with UTRA TDD BS.

The blocking performance requirement applies to interfering signals with center frequency within the ranges specified in the tables below, using a 1MHz step size.

In case this additional blocking requirement is applied, the static reference performance as specified in clause 7.2.1 shall be met with a wanted and an interfering signal coupled to BS antenna input using the following parameters.

Table 7.9: Additional blocking requirements for operating bands defined in subclause 4.2 a) when co-located with GSM900

Center Frequency of Interfering Signal	Interfering Signal Level	Wanted Signal Level	Minimum Offset of Interfering Signal	Type of Interfering Signal
921 – 960 MHz	+16 dBm	<REFSENS> + 6 dB	—	CW carrier

Table 7.10: Additional blocking requirements for operating bands defined in subclause 4.2 a) when co-located with DCS1800

Center Frequency of Interfering Signal	Interfering Signal Level	Wanted Signal Level	Minimum Offset of Interfering Signal	Type of Interfering Signal
1805 - 1880	+16 dBm	<REFSENS> + 6 dB	—	CW carrier

The normative reference for this requirement is TS 25.105 [1] subclause 7.5.1.1.

7.5.2.2 1,28 Mcps TDD option

7.5.2.2.1 General requirements

The static reference performance as specified in clause 7.2 shall be met with a wanted and an interfering signal coupled to the BS antenna input using the parameters specified in tables 7.6A,7.7A or 7.8A, respectively.

Table 7.6A: Blocking requirements for operating bands defined in subclause 4.2 a) for 1,28 Mcps TDD

Center frequency of interfering signal	Interfering signal level	Wanted signal level	Minimum offset of interfering signal	Type of interfering signal
1900 – 1920 MHz, 2010 – 2025 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1880 – 1900 MHz, 1990 – 2010 MHz, 2025 – 2045 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1920 – 1980 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1 - 1880 MHz, 1980 – 1990 MHz, 2045 – 12750 MHz	-15 dBm	<REFSENS> + 6 dB	—	CW carrier

Table 7.7A: Blocking requirements for operating bands defined in subclause 4.2 b)for 1,28 Mcps TDD

Center frequency of interfering signal	Interfering signal level	Wanted signal level	Minimum offset of interfering signal	Type of interfering signal
1850 – 1990 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1830 – 1850 MHz, 1990 – 2010 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1 – 1830 MHz, 2010 – 12750 MHz	-15 dBm	<REFSENS> + 6 dB	—	CW carrier

Table 7.8A: Blocking requirements for operating bands defined in subclause 4.2 c)for 1,28 Mcps TDD

Center frequency of interfering signal	Interfering signal level	Wanted signal level	Minimum offset of interfering signal	Type of interfering signal
1910 – 1930 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1890 – 1910 MHz, 1930 – 1950 MHz	-40 dBm	<REFSENS> + 6 dB	3.2 MHz	1,28 Mcps TDD signal with one code
1 – 1890 MHz, 1950 – 12750 MHz	-15 dBm	<REFSENS> + 6 dB	—	CW carrier

The normative reference for this requirement is TS 25.105 [1] subclause 7.5.0.2.

7.5.2.2.2 Co-location with GSM900 and/or DCS 1800

This additional blocking requirement may be applied for the protection of TDD BS receivers when GSM900 and/or DCS1800 BTS are co-located with UTRA TDD BS.

The blocking performance requirement applies to interfering signals with center frequency within the ranges specified in the tables below, using a 1MHz step size.

In case this additional blocking requirement is applied, the static reference performance as specified in clause 7.2.1 shall be met with a wanted and an interfering signal coupled to BS antenna input using the following parameters.

Table 7.9A: Additional blocking requirements for operating bands defined in 4.2(a) when co-located with GSM900

Centre Frequency of Interfering Signal	Interfering Signal Level	Wanted Signal Level	Minimum Offset of Interfering Signal	Type of Interfering Signal
921 – 960 MHz	+16 dBm	<REFSENS> + 6 dB	—	CW carrier

Table 7.10A: Additional blocking requirements for operating bands defined in 4.2(a) when co-located with DCS1800

Center Frequency of Interfering Signal	Interfering Signal Level	Wanted Signal Level	Minimum Offset of Interfering Signal	Type of Interfering Signal
1805 – 1880	+16 dBm	<REFSENS> + 6 dB	—	CW carrier

The normative reference for this requirement is TS 25.105 [1] subclause 7.5.1.2.

7.5.3 Test purpose

7.5.3.1 3,84 Mcps TDD option

The test stresses the ability of the BS receiver to withstand high-level interference from unwanted signals at frequency offsets of 10 MHz or more, without undue degradation of its sensitivity.

7.5.3.2 1,28 Mcps TDD option

The test stresses the ability of the BS receiver to withstand high-level interference from unwanted signals at frequency offsets of 3,2 MHz or more, without undue degradation of its sensitivity.

7.5.4 Method of test

7.5.4.1 Initial conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: M; see subclause 5.3.
The BS shall be configured to operate as close to the centre of the operating band as possible.

(1) Connect an UE simulator operating at the assigned channel frequency of the wanted signal and a signal generator to the antenna connector of one Rx port.

(2) Terminate or disable any other Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12,2 kbps) defined in Annex A.2.1.The level of the UE simulator signal measured at the BS antenna connector shall be set to 6 dB above the reference sensitivity level specified in subclause 7.2.2.

7.6 Intermodulation characteristics

7.6.1 Definition and applicability

Third and higher order mixing of two interfering RF signals can produce an interfering signal in the band of the desired channel. Intermodulation response rejection is a measure of the capability of the receiver to receive a wanted signal on its assigned channel frequency in the presence of two or more interfering signals which have a specific frequency relationship to the wanted signal.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.6.2 Minimum Requirements

7.6.2.1 3,84 Mcps TDD option

The static reference performance as specified in clause 7.2 should be met when the following signals are coupled to the BS antenna input.

- A wanted signal at the assigned channel frequency, 6 dB above the static reference level.
- Two interfering signals with the parameters specified in table 7.11.

Table 7.11: Parameters of the interfering signals for intermodulation characteristics testing

Interfering Signal Level	Offset	Type of Interfering Signal
- 48 dBm	10 MHz	CW signal
- 48 dBm	20 MHz	WCDMA signal with one code

The normative reference for this requirement is TS 25.105 [1] subclause 7.6.1.1.

7.6.2.2 1,28 Mcps TDD option

The static reference performance as specified in clause 7.2 should be met when the following signals are coupled to the BS antenna input.

- A wanted signal at the assigned channel frequency, 6 dB above the static reference level.
- Two interfering signals with the parameters specified in table 7.11A.

Table 7.11A: Parameters of the interfering signals for intermodulation characteristics testing for 1,28 Mcps TDD

Interfering Signal Level	Offset	Type of Interfering Signal
- 48 dBm	3,2 MHz	CW signal
- 48 dBm	6,4 MHz	1,28 Mcps TDD signal with one code

The normative reference for this requirement is TS 25.105 [1] subclause 7.6.1.2.

7.6.3 Test purpose

The test purpose is to verify the ability of the BS receiver to inhibit the generation of intermodulation products in its non-linear elements caused by the presence of two high-level interfering signals at frequencies with a specific relationship to the frequency of the wanted signal.

7.6.4 Method of test

7.6.4.1 Initial conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect an UE simulator operating at the assigned channel frequency of the wanted signal and two signal generators to the antenna connector of one Rx port.

(2) Terminate or disable any other Rx port not under test.

(3) Start transmission from the BS tester to the BS using the UL reference measurement channel (12,2 kbps) defined in Annex A.2.1. The level of the UE simulator signal measured at the BS antenna connector shall be set to 6 dB above the reference sensitivity level specified in subclause 7.2.2.

(4) Set the first signal generator to produce a CW signal with a level measured at the BS antenna connector of -48 dBm.

(5) Set the second signal generator to produce an interfering signal equivalent to a wideband CDMA signal with one code of chip frequency, filtered by an RRC transmit pulse-shaping filter with roll-off $\alpha = 0,22$. The level of the signal measured at the BS antenna connector shall be set to - 48 dBm.

7.7 Spurious emissions

7.7.1 Definition and applicability

The spurious emissions power is the power of emissions generated or amplified in a receiver that appear at the BS antenna connector. The requirements apply to all BS with separate Rx and Tx antenna connectors. For BS equipped with only a single antenna connector for both transmitter and receiver, the requirements of subclause 6.6.3 shall apply to this port, and this test need not be performed.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.7.2 Minimum Requirements

7.7.2.1 3,84 Mcps TDD option

The power of any spurious emission shall not exceed the values given in table 7.12.

Table 7.12: Receiver spurious emission requirements

Band	Maximum level	Measurement Bandwidth	Note
9 kHz – 1 GHz	-57 dBm	100 kHz	
1 GHz – 1,9 GHz	-47 dBm	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
1,900 – 1,980 GHz	-78 dBm	3,84 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
1,980 – 2,010 GHz	-47 dBm	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
2,010 – 2,025 GHz	-78 dBm	3,84 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
2,025 GHz – 12,75 GHz	-47 dBm	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS

The normative reference for this requirement is TS 25.105 [1] subclause 7.7.1.1.

7.7.2.2 1,28 Mcps TDD option

The power of any spurious emission shall not exceed the values given in table 7.12A.

Table 7.12A: Receiver spurious emission requirements for 1,28 Mcps TDD

Band	Maximum level	Measurement Bandwidth	Note
9 kHz – 1 GHz	-57 dBm	100 kHz	
1 GHz – 1.9 GHz and 1.98 GHz – 2.01 GHz	-47 dBm	1 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.
1.9 GHz – 1.98 GHz and 2.01 GHz – 2.025 GHz	-83 dBm	1.28 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.
2.025 GHz – 12.75 GHz	-47 dBm	1 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.

The normative reference for this requirement is TS 25.105 [1] subclause 7.7.1.2.

7.7.3 Test purpose

The test purpose is to verify the ability of the BS to limit the interference caused by receiver spurious emissions to other systems.

7.7.4 Method of test

7.7.4.1 Initial conditions

7.7.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: M; see subclause 5.3.

7.7.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: M; see subclause 5.3.~~

(1) Connect the measuring equipment to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Set the BS receiver to operational mode.

(4) Set the BS to transmit a signal with parameters according to table 7.13.

(5) Terminate the Tx port(s).

Table 7.13: Parameters of the transmitted signal for Rx spurious emissions test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

7.7.4.1.32 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Set the BS receiver to operational mode.

(4) Set the BS to transmit a signal with parameters according to table 7.13A.

(5) Terminate the Tx port(s).

8 Performance requirements

8.1 General

Performance requirements for the BS are specified for the measurement channels defined in Annex A and the propagation conditions in Annex B. The requirements only apply to those measurement channels that are supported by the base station.

The minimum bandwidth of the white noise source, simulating interference from other cells (I_{oc}) shall be 1,5 times the chip rate.

The requirements only apply to a base station with dual receiver antenna diversity. The required $\hat{I}_{or}/I_{oc}$ shall be applied separately at each antenna port.

Table 8.1: Summary of Base Station performance targets

Physical channel	Measurement channel	Static	Multi-path Case 1	Multi-path Case 2	Multi-path Case 3
		Performance metric			
DCH	12,2 kbps	BLER < 10^{-2}	BLER < 10^{-2}	BLER < 10^{-2}	BLER < 10^{-2}
	64 kbps	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}, 10^{-3}
	144 kbps	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}, 10^{-3}
	384 kbps	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}	BLER < 10^{-1}, 10^{-2}, 10^{-3}

8.2 Demodulation in static propagation conditions

8.2.1 Demodulation of DCH

8.2.1.1 Definition and applicability

The performance requirement of DCH in static propagation conditions is determined by the maximum Block Error Ratio (BLER) allowed when the receiver input signal is at a specified $\hat{I}_{or}/I_{oc}$ limit. The BLER is calculated for each of the measurement channels supported by the base station.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

8.2.1.2 Minimum Requirements

8.2.1.2.1 3,84 Mcps TDD option

For the parameters specified in table 8.2, the BLER should not exceed the piece-wise linear BLER curve specified in table 8.3. These requirements are applicable for TFCS size 16.

Table 8.2: Parameters in static propagation conditions

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		6	4	0	0
$\frac{DPCH_o \_ E_c}{I_{or}}$	DB	-9	-9,5	–	–
I_{oc}	dBm/3,84 MHz	-89			
Information Data Rate	Kbps	12,2	64	144	384

Table 8.3: Performance requirements in AWGN channel.

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	-1,9	10^{-2}
2	-0,3	10^{-1}
	0,0	10^{-2}
3	0,0	10^{-1}
	0,2	10^{-2}
4	-0,5	10^{-1}
	-0,3	10^{-2}

The normative reference for this requirement is TS 25.105 [1] subclause 8.2.1.1.1.

8.2.1.2.2 1,28 Mcps TDD option

For the parameters specified in table 8.2A, the BLER should not exceed the piece-wise linear BLER curve specified in table 8.3A. These requirements are applicable for TFCS size 16.

Table 8.2A: Parameters in static propagation conditions for 1,28 Mcps TDD

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		4	1	1	0
Spread factor of $DPCH_o$		8	8	8	
$\frac{DPCH_o\_E_c}{I_{or}}$	dB	-7	-7	-7	–
I_{oc}	dBm/1,28 MHz	-91			
Information Data Rate	kbps	12,2	64	144	384

Table 8.3A: Performance requirements in AWGN channel for 1,28 Mcps TDD

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	0.6	10^{-2}
2	-0.9	10^{-1}
	-0.4	10^{-2}
3	-0.3	10^{-1}
	-0.1	10^{-2}
4	0.5	10^{-1}
	0.6	10^{-2}

The normative reference for this requirement is TS 25.105 [1] subclause 8.2.1.1.2.

8.2.1.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed test signal under static propagation conditions with a BLER not exceeding a specified limit. Within the wanted channel, intracell interference sources as well as an additional intercell interference source are taken into account. Therefore, this test – as all other tests in clause 8 - mainly checks the ability of the signal processing part of the receiver to extract the wanted signal from the interfered-with input signal, whereas the tests in clause 7 concentrate on the receiver RF part.

8.2.1.4 Method of test

8.2.1.4.1 Initial conditions

8.2.1.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

8.2.1.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 16, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.2.

8.2.1.4.1.3~~2~~ 1,28 Mcps TDD option

Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 8, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.2A.

8.3 Demodulation of DCH in multipath fading conditions

8.3.1 Multipath fading Case 1

8.3.1.1 Definition and applicability

The performance requirement of DCH in multipath fading Case 1 is determined by the maximum Block Error Ratio (BLER) allowed when the receiver input signal is at a specified $\hat{I}_{or}/I_{oc}$ limit. The BLER is calculated for each of the measurement channels supported by the base station.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

8.3.1.2 Minimum Requirements

8.3.1.2.1 3,84 Mcps TDD option

For the parameters specified in table 8.5, the BLER should not exceed the piece-wise linear BLER curve specified in table 8.6. These requirements are applicable for TFCS size 16.

Table 8.5: Parameters in multipath Case 1 channel

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		6	4	0	0
$\frac{DPCH_o \_ E_c}{I_{or}}$	DB	-9	-9,5	–	–
I_{oc}	dBm/3,84 MHz	-89			
Information Data Rate	Kbps	12,2	64	144	384

Table 8.6: Performance requirements in multipath Case 1 channel.

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	6,3	10^{-2}
2	5,5	10^{-1}
	9,4	10^{-2}
3	5,6	10^{-1}
	9,4	10^{-2}
4	5,5	10^{-1}
	8,7	10^{-2}

The normative reference for this requirement is TS 25.105 [1] subclause 8.3.1.1.1.

8.3.1.2.2 1,28 Mcps TDD option

For the parameters specified in table 8.5A, the BLER should not exceed the piece-wise linear BLER curve specified in table 8.6A. These requirements are applicable for TFCS size 16.

Table 8.5A: Parameters in multipath Case 1 channel for 1,28 Mcps TDD

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		4	1	1	0
Spread factor of $DPCH_o$		8	8	8	
$\frac{DPCH_o - E_c}{I_{or}}$	dB	-7	-7	-7	–
I_{oc}	dBm/1,28 MHz	-91			
Information Data Rate	kbps	12,2	64	144	384

Table 8.6A: Performance requirements multipath Case 1 channel for 1,28 Mcps TDD

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	10.4	10^{-2}
2	5.3	10^{-1}
	9.4	10^{-2}
3	5.7	10^{-1}
	10.1	10^{-2}
4	6.0	10^{-1}
	10.0	10^{-2}

The normative reference for this requirement is TS 25.105 [1] subclause 8.3.1.1.2.

8.3.1.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed test signal under defined propagation conditions (multipath fading Case 1) with a BLER not exceeding a specified limit. Within the wanted channel, independent intracell interference sources as well as an additional intercell interference source are taken into account. Therefore, this test – as all other tests in clause 8 - mainly checks the ability of the signal processing part of the receiver to extract the wanted signal from the distorted and interfered-with input signal, whereas the tests in clause 7 concentrate on the receiver RF part.

8.3.1.4 Method of test

8.3.1.4.1 Initial conditions

8.3.1.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

8.3.1.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently

called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 16, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.5.

(2) The wanted signal produced by the BS tester and the interfering signals produced by the $DPCH_0$ generators are individually passed through independent Multipath Fading Simulators (MFS) before entering the combining network. Each MFS shall be configured to simulate multipath fading Case 1.

8.3.1.4.1.~~2~~3 1,28 Mcps TDD option

(1) Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 8, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.5A.

(2) The wanted signal produced by the BS tester and the interfering signals produced by the $DPCH_0$ generators are individually passed through independent Multipath Fading Simulators (MFS) before entering the combining network. Each MFS shall be configured to simulate multipath fading Case 1.

8.3.2 Multipath fading Case 2

8.3.2.1 Definition and applicability

The performance requirement of DCH in multipath fading Case 2 is determined by the maximum Block Error Ratio (BLER) allowed when the receiver input signal is at a specified $\hat{I}_{or}/I_{oc}$ limit. The BLER is calculated for each of the measurement channels supported by the base station.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

8.3.2.2 Minimum Requirements

8.3.2.2.1 3,84 Mcps TDD option

For the parameters specified in table 8.8, the BLER should not exceed the piece-wise linear BLER curve specified in table 8.8. These requirements are applicable for TFCS size 16.

Table 8.8: Parameters in multipath Case 2 channel

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		2	0	0	0
$\frac{DPCH_o - E_c}{I_{or}}$	DB	-6	–	–	–
I_{oc}	dBm/3,84 MHz	-89			
Information Data Rate	Kbps	12,2	64	144	384

Table 8.9: Performance requirements in multipath Case 2 channel.

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	0,1	10^{-2}
2	0,4	10^{-1}
	2,8	10^{-2}
3	3,6	10^{-1}
	6,0	10^{-2}
4	3,0	10^{-1}
	5,4	10^{-2}

The normative reference for this requirement is TS 25.105 [1] subclause 8.3.2.1.1.

8.3.2.2.2 1,28 Mcps option

For the parameters specified in table 8.8A, the BLER should not exceed the piece-wise linear BLER curve specified in table 8.9A. These requirements are applicable for TFCS size 16.

Table 8.8A: Parameters in multipath Case 2 channel for 1,28 Mcps TDD

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		4	1	1	0
Spread factor of $DPCH_o$		8	8	8	
$\frac{DPCH_o - E_c}{I_{or}}$	dB	-7	-7	-7	–
I_{oc}	dBm/1,28 MHz	-91			
Information Data Rate	kbps	12,2	64	144	384

Table 8.9A: Performance requirements multipath Case 2 channel for 1,28 Mcps TDD.

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	6.7	10^{-2}
2	3.6	10^{-1}
	5.9	10^{-2}
3	4.2	10^{-1}
	6.3	10^{-2}
4	4.6	10^{-1}
	6.0	10^{-2}

The normative reference for this requirement is TS 25.105 [1] subclause 8.3.2.1.2.

8.3.2.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed test signal under defined propagation conditions (multipath fading Case 2) with a BLER not exceeding a specified limit. Within the wanted channel, independent intracell interference sources as well as an additional intercell interference source are taken into account. Therefore, this test – as all other tests in clause 8 - mainly checks the ability of the signal processing part of the receiver to extract the wanted signal from the distorted and interfered-with input signal, whereas the tests in clause 7 concentrate on the receiver RF part.

8.3.2.4 Method of test

8.3.2.4.1 Initial conditions

8.3.2.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

8.3.2.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 16, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.8.

(2) The wanted signal produced by the BS tester and the interfering signals produced by the $DPCH_0$ generators are individually passed through independent Multipath Fading Simulators (MFS) before entering the combining network. Each MFS shall be configured to simulate multipath fading Case 2.

8.3.2.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 8, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.8A.

(2) The wanted signal produced by the BS tester and the interfering signals produced by the $DPCH_0$ generators are individually passed through independent Multipath Fading Simulators (MFS) before entering the combining network. Each MFS shall be configured to simulate multipath fading Case 2.

8.3.3 Multipath fading Case 3

8.3.3.1 Definition and applicability

The performance requirement of DCH in multipath fading Case 3 is determined by the maximum Block Error Ratio (BLER) allowed when the receiver input signal is at a specified $\hat{I}_{or}/I_{oc}$ limit. The BLER is calculated for each of the measurement channels supported by the base station.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

8.3.3.2 Minimum Requirements

8.3.3.2.1 3,84 Mcps TDD option

For the parameters specified in table 8.11, the BLER should not exceed the piece-wise linear BLER curve specified in Table 8.12. These requirements are applicable for TFCS size 16.

Table 8.11: Parameters in multipath Case 3 channel

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		2	0	0	0
$\frac{DPCH_o - E_c}{I_{or}}$	DB	-6	–	–	–
I_{oc}	dBm/3,84 MHz	-89			
Information Data Rate	Kbps	12,2	64	144	384

Table 8.12: Performance requirements in multipath Case 3 channel.

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	-0,6	10^{-2}
2	0,7	10^{-1}
	2,4	10^{-2}
	3,8	10^{-3}
3	3,9	10^{-1}
	5,9	10^{-2}
	7,3	10^{-3}
4	2,8	10^{-1}
	4,2	10^{-2}
	4,8	10^{-3}

The normative reference for this requirement is TS 25.105 [1] subclause 8.3.3.1.1.

8.3.3.2.2 1,28 Mcps TDD option

For the parameters specified in table 8.11A, the BLER should not exceed the piece-wise linear BLER curve specified in Table 8.12A. These requirements are applicable for TFCS size 16.

Table 8.11A: Parameters in multipath Case 3 channel (1,28 Mcps option)

Parameters	Unit	Test 1	Test 2	Test 3	Test 4
Number of $DPCH_o$		4	1	1	0
Spread factor of $DPCH_o$		8	8	8	
$\frac{DPCH_o - E_c}{I_{or}}$	dB	-7	-7	-7	–
I_{oc}	dBm/1,28 MHz	-91			
Information Data Rate	kbps	12,2	64	144	384

Table 8.12A: Performance requirements multipath Case 3 channel (1,28 Mcps option).

Test Number	$\frac{\hat{I}_{or}}{I_{oc}}$ [dB]	BLER
1	5.6	10^{-2}
2	3.2	10^{-1}
	4.6	10^{-2}
	5.9	10^{-3}
3	3.7	10^{-1}
	4.8	10^{-2}
	5.9	10^{-3}
4	4.2	10^{-1}
	5.1	10^{-2}
	5.9	10^{-3}

The normative reference for this requirement is TS 25.105 [1] subclause 8.3.3.1.2.

8.3.3.3 Test purpose

The test purpose is to verify the ability of the BS to receive a prescribed test signal under defined propagation conditions (multipath fading Case 3) with a BLER not exceeding a specified limit. Within the wanted channel, independent intracell interference sources as well as an additional intercell interference source are taken into account. Therefore, this test – as all other tests in clause 8 - mainly checks the ability of the signal processing part of the receiver to extract the wanted signal from the distorted and interfered-with input signal, whereas the tests in clause 7 concentrate on the receiver RF part.

8.3.3.4 Method of test

8.3.3.4.1 Initial conditions

8.3.3.4.1.1 General test conditions

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

8.3.3.4.1.2~~1~~ 3,84 Mcps TDD option

~~Test environment: normal; see subclause 5.9.1.~~

~~RF channels to be tested: B, M and T; see subclause 5.3.~~

(1) Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 16, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.11.

(2) The wanted signal produced by the BS tester and the interfering signals produced by the $DPCH_0$ generators are individually passed through independent Multipath Fading Simulators (MFS) before entering the combining network. Each MFS shall be configured to simulate multipath fading Case 3.

8.3.3.4.1.3~~2~~ 1,28 Mcps TDD option

(1) Connect the BS tester (UE simulator) generating the wanted signal and a set of interference generators to both BS antenna connectors for diversity reception via a combining network. The set of interference generators comprises a number of CDMA generators, each representing an individual intracell interferer (subsequently called $DPCH_0$ generators), and an additional band-limited white noise source, simulating interference from other cells. Each $DPCH_0$ generator shall produce an interfering signal that is equivalent to a valid UTRA TDD signal with spreading factor 8, using the same time slot(s) than the wanted signal and applying the same cell-specific scrambling code. The number of the $DPCH_0$ generators used in each test is given in table 8.11A.

(2) The wanted signal produced by the BS tester and the interfering signals produced by the $DPCH_0$ generators are individually passed through independent Multipath Fading Simulators (MFS) before entering the combining network. Each MFS shall be configured to simulate multipath fading Case 3.

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CR-Form-v4

CHANGE REQUEST

⌘ **25.142** **CR** **85** ⌘ ev **-** ⌘ Current version: **4.1.0** ⌘

*For **HELP** on using this form, see bottom of this page or look at the pop-up text over the ⌘ symbols.*

Proposed change affects: ⌘ (U)SIM ☐ ME/UE ☐ Radio Access Network ☒ Core Network ☐

Title:	⌘	Power and ACLR definition corrections for 1.28 Mcps TDD option
Source:	⌘	RAN WG4
Work item code:	⌘	LCRTDD-RF
Date:	⌘	3-7/09/2001
Category:	⌘	**F**
Release:	⌘	Rel-4

Use one of the following categories:
F *(correction)*
A *(corresponds to a correction in an earlier release)*
B *(addition of feature),*
C *(functional modification of feature)*
D *(editorial modification)*
Detailed explanations of the above categories can be found in 3GPP TR 21.900.

Use one of the following releases:

2	*(GSM Phase 2)*
R96	*(Release 1996)*
R97	*(Release 1997)*
R98	*(Release 1998)*
R99	*(Release 1999)*
REL-4	*(Release 4)*
REL-5	*(Release 5)*

Reason for change:	⌘	New power definition.
Summary of change:	⌘	Renaming of the transmit power into output power. Clarification of Maximum output power procedure
Consequences if not approved:	⌘	Possible misunderstanding of several powers may result in non-consistent conformance measurements.

Clauses affected:	⌘	6.2.4.2.2, 6.4.2.4.2.2; 6.4.3.4.2.2; 6.4.4.4.1.2; 6.4.4.4.2.2; 6.6.1.4.2.2; 6.6.2.2.4.2
Other specs affected:	⌘	☐ Other core specifications ☐ Test specifications ☐ O&M Specifications
Other comments:	⌘	

How to create CRs using this form:

Comprehensive information and tips about how to create CRs can be found at: http://www.3gpp.org/3G_Specs/CRs.htm. Below is a brief summary:

1) Fill out the above form. The symbols above marked ⌘ contain pop-up help information about the field that they are closest to.

2) Obtain the latest version for the release of the specification to which the change is proposed. Use the MS Word "revision marks" feature (also known as "track changes") when making the changes. All 3GPP specifications can be downloaded from the 3GPP server under ftp://ftp.3gpp.org/specs/ For the latest version, look for the directory name with the latest date e.g. 2001-03 contains the specifications resulting from the March 2001 TSG meetings.

3) With "track changes" disabled, paste the entire CR form (use CTRL-A to select it) into the specification just in front of the clause containing the first piece of changed text. Delete those parts of the specification which are not relevant to the change request.

6.2 Maximum output power

6.2.1 Definition and applicability

Output power, Pout, of the base station is the power of one carrier delivered to a load with resistance equal to the nominal load impedance, when averaged (in the sense of thermal power) over the useful part of the burst (time slot).

Rated output power, PRAT, of the base station is the mean power level per carrier over an active timeslot that the manufacturer has declared to be available at the antenna connector.

Maximum output power, Pmax, of the base station is the mean power level per carrier over an active timeslot measured at the antenna connector for a specified reference condition.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.2.2 Minimum Requirements

In normal conditions, the base station maximum output power shall remain within +2 dB and –2 dB of the manufacturer's rated output power.

In extreme conditions, the base station maximum output power shall remain within +2,5 dB and –2,5 dB of the manufacturer's rated output power.

In certain regions, the minimum requirement for normal conditions may apply also for some conditions outside the ranges defined for the Normal test environment in subclause 5.9.1.

The normative reference for this requirement is TS 25.105 [1] subclause 6.2.1.1.

6.2.3 Test purpose

The test purpose is to verify the accuracy of the maximum output power across the frequency range and under normal and extreme conditions for all transmitters in the BS.

6.2.4 Method of test

6.2.4.1 Initial conditions

6.2.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

In addition, on one UARFCN only, the test shall be performed under extreme power supply as defined in subclause 5.9.4.

NOTE: Tests under extreme power supply also test extreme temperature.

(1) The transmitter under test and all other transmitters of the base station (if any) are switched on.

(2) The power of the transmitters not under test (if any) are controlled down.

(3) Connect the power measuring equipment to the BS antenna connector.

(4) Set the parameters of the transmitted signal according to table 6.1.

Table 6.1: Parameters of the transmitted signal for maximum output power test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.2.4.1.2 1,28 Mcps TDD option

(1) The transmitter under test and all other transmitters of the base station (if any) are switched on.

(2) The power of the transmitters not under test (if any) are controlled down.

(3) Connect the power measuring equipment to the BS antenna connector.

(4) Set the parameters of the transmitted signal according to table 6.1A.

Table 6.1A: Parameters of the transmitted signal for maximum output power test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, 3, 4, 5, 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
BS output power setting	PRAT
Number of DPCH in each active TS	8
Power of each DPCH	1/8 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.2.4.2 Procedure

6.2.4.2.1 3,84 Mcps TDD option

(1) Measure thermal power over the 2464 active chips of an even time slot (this excludes the guard periods), and with a measurement bandwidth of at least 5 MHz.

(2) Run step (1) for RF channels Low / Mid / High.

6.2.4.2.2 1,28 Mcps TDD option

(1) Measure thermal power of the BS output signal over the 848 active chips of an even time slot TS i (this excludes the guard periods), and with a measurement bandwidth of at least 1,6 MHz.

(2) Run step (1) for RF channels Low / Mid / High.

----------NEXT SECTION----------

6.4.2 Power control steps

6.4.2.1 Definition and applicability

The power control step is the step change in the DL transmitter output power in response to a TPC message from the UE.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.2.2 Minimum Requirements

The power control step sizes in the DL shall be 1 dB, 2 dB and 3 dB.

The tolerance of the transmitter output power and the greatest average rate of change in mean power due to the power control step shall be within the range shown in Table 6.3.

Table 6.3: Power control step size tolerance

Step size	Tolerance	Range of average rate of change in mean power per 10 steps	
		Minimum	maximum
1dB	± 0,5 dB	± 8 dB	± 12 dB
2dB	± 0,75 dB	± 16 dB	± 24 dB
3dB	± 1 dB	± 24 dB	± 36 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.2.1.

6.4.2.3 Test purpose

The DL power control is applied to adjust the BS output power to a value that is sufficiently high to generate a SIR at the UE receiver equal to the target SIR, while limiting the intercell interference.

The test purpose is to verify the ability of the BS to interpret received TPC commands in a correct way and to adjust its output power according to these commands with the specified accuracy.

6.4.2.4 Method of test

6.4.2.4.1 Initial conditions

6.4.2.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Disable closed loop power control in the BS under test.

(3) Set the initial parameters of the BS transmitted signal according to table 6.4.

(4) Operate the BS in such a mode that it is able to interpret received TPC commands.

(5) Start BS transmission.

NOTE: The BS tester used for this test must have the ability:

- to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C;
- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.4: Initial parameters of the BS transmitted signal for power control steps test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	1
DPCH power	Minimum
Data content of DPCH	real life (sufficient irregular)

6.4.2.4.1.2 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Disable closed loop power control in the BS under test.

(3) Set the initial parameters of the BS transmitted signal according to table 6.4A.

(4) Operate the BS in such a mode that it is able to interpret received TPC commands.

(5) Start BS transmission.

NOTE: The BS tester used for this test must have the ability

- to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C;
- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.4A: Initial parameters of the BS transmitted signal for power control steps test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 6: transmit, if i is 0, 4,5,6; receive, if i is 1,2,3.
Number of DPCH in each active TS	1
DPCH power	Minimun
Data content of DPCH	real life (sufficient irregular)

6.4.2.4.2 Procedure

6.4.2.4.2.1 3,84 Mcps TDD option

(1) Configure the BS transmitter to enable power control steps of size 1 dB.

(2) Set the BS tester to produce a sequence of TPC commands related to the active DPCH. This sequence shall be transmitted to the BS within the odd time slots TS i (receive time slots of the BS) and shall consist of a series of TPC commands with content "Increase Tx power", followed by a series of TPC commands with content "Decrease Tx power". Each of these series should be sufficiently long so that the transmit output power of the active DPCH is controlled to reach its maximum and its minimum, respectively.

(3) Measure the power of the active DPCH over the 2464 active chips of each even time slot TS i (this excludes the guard period) , and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(4) Based on the measurement made in step (3), calculate the power control step sizes and the average rate of change per 10 steps.

(5) Configure the BS transmitter to enable power control steps of 2 dB and of 3 dB, respectively, and repeat steps (2) to (4).

6.4.2.4.2.2 1,28 Mcps TDD option

(1) Configure the BS transmitter to enable power control steps of size 1 dB.

(2) Set the BS tester to produce a sequence of TPC commands related to the active DPCH. This sequence shall be transmitted to the BS within the odd time slots TS i (receive time slots of the BS) and shall consist of a series of TPC commands with content "Increase Tx power", followed by a series of TPC commands with content "Decrease Tx power". Each of these series should be sufficiently long so that the ~~transmit~~ output power of the active DPCH is controlled to reach its maximum and its minimum, respectively.

(3) Measure the power of the active DPCH over the 848 active chips of each even time slot TS i (this excludes the guard period) , and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(4) Based on the measurement made in step (3), calculate the power control step sizes and the average rate of change per 10 steps.

(5) Configure the BS transmitter to enable power control steps of 2 dB and of 3 dB, respectively, and repeat steps (2) to (4).

6.4.2.5 Test Requirements

NOTE: If the Test Requirements below differ from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

6.4.2.5.1 3,84 Mcps TDD option

For all measurements, the tolerance of the power control step sizes and the average rate of change per 10 steps shall be within the limits given in Table 6.5.

Table 6.5: Test Requirements for power control step size tolerance

Step size	Single step tolerance	Range of average rate of change in mean power per 10 steps	
		Minimum	maximum
1dB	± 0,6 dB	± 7,7 dB	± 12,3 dB
2dB	± 0,85 dB	± 15,7 dB	± 24,3 dB
3dB	± 1,1 dB	± 23,7 dB	± 36,3 dB

In case, the power control step size is set to 3 dB, the number of power control steps feasible within the power control dynamic range of the BS under test may be less than 10. In this case, the evaluation of the average rate of change in mean power shall be based on the number of power control steps actually feasible, and the permitted range of average rate of change shall be reduced compared to the values given in table 6.51 in proportion to the ratio (number of power control steps actually feasible /10).

EXAMPLE: If the number of power control steps actually feasible is 9, the minimum and maximum value of the range of average rate of change in mean power are given by ±21,3 dB and ±32,7 dB, respectively.

6.4.2.5.2 1,28 Mcps TDD option

For all measurements, the tolerance of the power control step sizes and the average rate of change per 10 steps shall be within the limits given in Table 6.3.

In case, the power control step size is set to 3 dB, the number of power control steps feasible within the power control dynamic range of the BS under test may be less than 10. In this case, the evaluation of the average rate of change in

mean power shall be based on the number of power control steps actually feasible, and the permitted range of average rate of change shall be reduced compared to the values given in table 6.4A in proportion to the ratio (number of power control steps actually feasible /10).

EXAMPLE: If the number of power control steps actually feasible is 9, the minimum and maximum value of the range of average rate of change in mean power are given by 21,6 dB and 32,4 dB, respectively.

6.4.3 Power control dynamic range

6.4.3.1 Definition and applicability

The power control dynamic range is the difference between the maximum and the minimum transmit output power for a specified reference condition.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.3.2 Minimum Requirements

The DL power control dynamic range shall be greater than or equal to 30 dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.3.1.

6.4.3.3 Test purpose

The test purpose is to verify the ability of the BS to control the power of a single code signal over the specified dynamic range.

6.4.3.4 Method of test

6.4.3.4.1 Initial conditions

6.4.3.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.6.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

NOTE: The BS tester used for this test must have the ability:

- to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C;

- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.6: Parameters of the BS transmitted signal for power control dynamic range test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	1
Data content of DPCH	real life (sufficient irregular)

6.4.3.4.1.2 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.6A.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

NOTE: The BS tester used for this test must have the ability

- to analyze the output signal of the BS under test with respect to code domain power, by applying the global in-channel Tx test method described in Annex C;

- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.6A: Parameters of the BS transmitted signal for power control dynamic range test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 6: transmit, if i is 0, 4,5,6; receive, if i is 1,2,3.
Number of DPCH in each active TS	1
Data content of DPCH	real life (sufficient irregular)

6.4.3.4.2 Procedure

6.4.3.4.2.1 3,84 Mcps TDD option

(1) Configure the BS transmitter to enable power control steps of size 1 dB.

(2) Set the BS tester to produce a sequence of TPC commands related to the active DPCH, with content "Increase Tx power". This sequence shall be sufficiently long so that the transmit output power of the active DPCH is controlled to reach its maximum, and shall be transmitted to the BS within the odd time slots TS i (receive time slots of the BS).

(3) Measure the power of the active DPCH over the 2464 active chips of an even time slot TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(4) Set the BS tester to produce a sequence of TPC commands related to the active DPCH, with content "Decrease Tx power". This sequence shall be sufficiently long so that the transmit output power of the active DPCH is controlled to reach its minimum, and shall be transmitted to the BS within the odd time slots TS i (receive time slots of the BS).

(5) Measure the power of the active DPCH over the 2464 active chips of an even time slot TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(6) Determine the power control dynamic range by calculating the difference between the maximum transmit output power measured in step (3) and the minimum transmit output power measured in step (5).

(7) Configure the BS transmitter to enable power control steps of 2 dB and of 3 dB, respectively, and repeat steps (2) to (6).

6.4.3.4.2.2 1,28 Mcps TDD option

(1) Configure the BS transmitter to enable power control steps of size 1 dB.

(2) Set the BS tester to produce a sequence of TPC commands related to the active DPCH, with content "Increase Tx power". This sequence shall be sufficiently long so that the ~~transmit~~ output power of the active DPCH is controlled to reach its maximum, and shall be transmitted to the BS within the receive time slots TS i of the BS.

(3) Measure the power of the active DPCH over the 848 active chips of an receive time slot TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(4) Set the BS tester to produce a sequence of TPC commands related to the active DPCH, with content "Decrease Tx power". This sequence shall be sufficiently long so that the ~~transmit~~ output power of the active DPCH is controlled to reach its minimum, and shall be transmitted to the BS within the receive time slots TS i of the BS.

(5) Measure the power of the active DPCH over the 848 active chips of a receive time slot TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(6) Determine the power control dynamic range by calculating the difference between the maximum ~~transmit~~ output power measured in step (3) and the minimum ~~transmit~~ output power measured in step (5).

(7) Configure the BS transmitter to enable power control steps of 2 dB and of 3 dB, respectively, and repeat steps (2) to (6).

6.4.3.5 Test Requirements

NOTE: If the Test Requirement below differs from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

The power control dynamic range derived according to subclause 6.4.3.4.2 shall be greater than or equal to 29,7 dB

6.4.4 Minimum transmit power

6.4.4.1 Definition and applicability

The minimum controlled output power of the BS is when the power control setting is set to a minimum value. This is when the power control indicates a minimum transmit output power is required.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.4.4.2 Minimum Requirements

The DL minimum transmit power shall be lower than or equal to:

Maximum output power - 30 dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.4.4.1.

6.4.4.3 Test purpose

The test purpose is to verify the ability of the BS to reduce its output power to a specified value.

6.4.4.4 Method of test

6.4.4.4.1 Initial conditions

6.4.4.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.7.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

NOTE: The BS tester used for this test must have the ability:

- to analyze the output signal of the BS under test with respect to thermal power;

- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.7: Parameters of the BS transmitted signal for minimum transmit power test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.4.4.4.1.2 1,28 Mcps TDD option

(1) Connect the BS tester to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.7A.

(3) Operate the BS in such a mode that it is able to interpret received TPC commands

(4) Start BS transmission.

NOTE: The BS tester used for this test must have the ability

- to analyze the output signal of the BS under test with respect to thermal power;

- to simulate an UE with respect to the generation of TPC commands embedded in a valid UE signal.

Table 6.7A: Parameters of the BS transmitted signal for minimum ~~transmit~~ power test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, 3, 4, 5, 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
BS output power setting	PRAT
Number of DPCH in each active TS	8
Power of each DPCH	1/8 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.4.4.4.2 Procedure

6.4.4.4.2.1 3,84 Mcps TDD option

(1) Configure the BS transmitter to enable power control steps of size 1 dB.

(2) Set the BS tester to produce a sequence of TPC commands related to all active DPCH, with content "Decrease Tx power". This sequence shall be sufficiently long so that the transmit output power of all active DPCH is

controlled to reach its minimum, and shall be transmitted to the BS within the odd time slots TS i (receive time slots of the BS).

(3) Measure the power of the BS output signal over the 2464 active chips of an even time slot TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(4) Configure the BS transmitter to enable power control steps of 2 dB and of 3 dB, respectively, and repeat steps (2) and (3).

6.4.4.4.2.2 1,28 Mcps TDD option

(1) Configure the BS transmitter to enable power control steps of size 1 dB.

(2) Set the BS tester to produce a sequence of TPC commands related to all active DPCH, with content "Decrease Tx power". This sequence shall be sufficiently long so that the ~~transmit~~ output power of all active DPCH is controlled to reach its minimum, and shall be transmitted to the BS within the receive time slots TS i of the BS.

(3) Measure the power of the BS output signal over the 848 active chips of a receive time slot TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off $\alpha = 0,22$ and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points.

(4) Configure the BS transmitter to enable power control steps of 2 dB and of 3 dB, respectively, and repeat steps (2) and (3).

6.4.4.5 Test Requirements

NOTE: If the Test Requirement below differs from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

For all measurements, the minimum transmit power derived in step (4) of subclause 6.4.4.4.2 shall be at least 29,3 dB below the maximum output power as declared by the manufacturer; see 6.2.

6.6 Output RF spectrum emissions

6.6.1 Occupied bandwidth

6.6.1.1 Definition and applicability

Occupied bandwidth is a measure of the bandwidth containing 99% of the total integrated power for transmitted spectrum and is centered on the assigned channel frequency.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.6.1.2 Minimum Requirements

6.6.1.2.1 3,84 Mcps TDD option

The occupied bandwidth shall be less than 5 MHz based on a chip rate of 3,84 Mcps.

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.1.

6.6.1.2.2 1,28 Mcps TDD option

The occupied bandwidth shall be less than 1.6 MHz based on a chip rate of 1,28 Mcps.

The reference for this requirement is TS 25.105 [1] subclause 6.6.1.

6.6.1.3 Test purpose

The occupied bandwidth, defined in the Radio Regulations of the International Telecommunication Union ITU, is a useful concept for specifying the spectral properties of a given emission in the simplest possible manner; see also Recommendation ITU-R SM.328-9 [7]. The test purpose is to verify that the emission of the BS does not occupy an excessive bandwidth for the service to be provided and is, therefore, not likely to create interference to other users of the spectrum beyond undue limits.

6.6.1.4 Method of test

6.6.1.4.1 Initial conditions

6.6.1.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.12.

Table 6.12: Parameters of the BS transmitted signal for occupied bandwidth testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	Real life (sufficient irregular)

6.6.1.4.1.2 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.12A.

Table 6.12A: Parameters of the BS transmitted signal for occupied bandwidth testing for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, 3, 4, 5, 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
BS output power setting	PRAT
Number of DPCH in each active TS	8
Power of each DPCH	1/8 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.6.1.4.2 Procedure

6.6.1.4.2.1 3,84 Mcps TDD option

(1) Measure the power of the transmitted signal with a measurement filter of bandwidth 30 kHz. The characteristic of the filter shall be approximately Gaussian (typical spectrum analyzer filter). The centre frequency of the filter shall be stepped in contiguous 30 kHz steps from a minimum frequency, which shall be (7,5 – 0,015) MHz below the assigned channel frequency of the transmitted signal, up to a maximum frequency, which shall be (7,5 – 0,015) MHz above the assigned channel frequency of the transmitted signal. The time duration of each step shall be sufficiently long to capture one active time slot. The measured power shall be recorded for each step.

(2) Determine the total transmitted power by accumulating the recorded power measurement results of all steps.

(3) Sum up the recorded power measurement results, starting from the step at the minimum frequency defined in (1) up to the step at a lower limit frequency by which this sum is equal to or greater than 0.5 % of the total power determined in (2). This limit frequency is recorded as "Lower Frequency".

(4) Sum up the recorded power measurement results, starting from the step at the maximum frequency defined in (1) down to the step at an upper limit frequency by which this sum is equal to or greater than 0.5 % of the total power determined in (2). This limit frequency is recorded as "Upper Frequency".

(5) Calculate the occupied bandwidth as the difference between the "Upper Frequency" obtained in (3) and the "Lower Frequency" obtained in (4).

6.6.1.4.2.2 1,28 Mcps TDD option

(1) Measure the power of the transmitted signal with a measurement filter of bandwidth 30 kHz. The characteristic of the filter shall be approximately Gaussian (typical spectrum analyser filter). The centre frequency of the filter shall be stepped in contiguous 30 kHz steps from a minimum frequency, which shall be (2,4 – 0,015) MHz below the assigned channel frequency of the transmitted signal, up to a maximum frequency, which shall be (2,4 – 0,015) MHz above the assigned channel frequency of the transmitted signal. The time duration of each step shall be sufficiently long to capture one active time slot. The measured power shall be recorded for each step.

(2) Determine the total ~~transmitted~~ output power by accumulating the recorded power measurement results of all steps.

(3) Sum up the recorded power measurement results, starting from the step at the minimum frequency defined in (1) up to the step at a lower limit frequency by which this sum is equal to or greater than 0,5 % of the total output power determined in (2). This limit frequency is recorded as "Lower Frequency".

(4) Sum up the recorded power measurement results, starting from the step at the maximum frequency defined in (1) down to the step at an upper limit frequency by which this sum is equal to or greater than 0,5 % of the output total power determined in (2). This limit frequency is recorded as "Upper Frequency".

(5) Calculate the occupied bandwidth as the difference between the "Upper Frequency" obtained in (3) and the "Lower Frequency" obtained in (4).

6.6.1.5 Test Requirements

NOTE: If the Test Requirement below differ from the Minimum Requirements, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

6.6.1.5.1 3,84 Mcps TDD option

The occupied bandwidth calculated in step (5) of subclause 6.6.1.4.2.1 shall be less than 5 MHz.

6.6.1.5.2 1,28 Mcps TDD option

The occupied bandwidth calculated in step (5) of subclause 6.6.1.4.2.2 shall be less than 1,6 MHz.

6.6.2.2 Adjacent Channel Leakage power Ratio (ACLR)

6.6.2.2.1 Definition and applicability

Adjacent Channel Leakage power Ratio (ACLR) is the ratio of the transmitted power to the power measured in an adjacent channel. Both the transmitted and the adjacent channel power are measured through a matched filter (root raised cosine and roll-off 0,22) with a noise power bandwidth equal to the chip rate. The requirements shall apply for all configurations of BS (single carrier or multi-carrier), and for all operating modes foreseen by the manufacturer's specification.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

6.6.2.2.2 Minimum Requirements

6.6.2.2.2.1 Minimum requirement

6.6.2.2.2.1.1 3,84 Mcps TDD option

The ACLR shall be equal to or greater than the limits given in table 6.22.

Table 6.22: BS ACLR limits

BS adjacent channel offset	ACLR limit
± 5 MHz	45 dB
± 10 MHz	55 dB

6.6.2.2.2.1.2 1,28 Mcps TDD option

The ACLR shall be equal to or greater than the limits given in Table 6.22A.

Table 6.22A: BS ACLR limits for 1,28 Mcps TDD

BS adjacent channel offset	ACLR limit
± 1.6 MHz	40 dB
± 3.2 MHz	50 dB

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.1.

6.6.2.2.2.2 Requirement in case of operation in proximity to TDD BS or FDD BS operating on an adjacent frequency

6.6.2.2.2.2.1 3,84 Mcps TDD option

In case the equipment is operated in proximity to another TDD BS or FDD BS on an adjacent frequency, the ACLR shall be equal to or greater than the value specified in table 6.23.

Table 6.23: BS ACLR limits in case of operation in proximity

BS adjacent channel offset	ACLR limit
± 5 MHz	70 dB
± 10 MHz	70 dB

The requirement is based on the assumption that the coupling loss between the base stations is at least 84dB.

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.2.

NOTE: The necessary dynamic range to very the conformance requirements specified in table 6.23 is at the limits of the capability of state-of-art measuring equipment.

6.6.2.2.2.2 1,28 Mcps TDD option

In case the equipment is operated in proximity to another TDD BS or FDD BS and both BSs operating on an adjacent frequency band , the requirement is specified in terms of power level of the transmitting BS. This requirement is valid for co-existence with non-frame and non-switching point synchronised systems operating on the closest used carrier. The interference power level shall not exceed the limit in Table 6.23A.

Table 6.23A: BS ACLR in case of operation in proximity for 1,28 Mcps TDD

Center Frequency for Measurement	Maximum Level of the interference power (in case of multiple antennas the interference powers shall be summed at all antenna connectors)	Measurement Bandwidth
Closest used carrier of the victim receiver: Either FDD carrier Or 3.84 Mcps TDD carrier Or 1.28 Mcps TDD carrier	-36 dBm	chip rate of the victim receiver: In case of FDD: 3.84 MHz In case of 3.84 Mcps TDD: 3.84 MHz In case of 1.28 Mcps TDD: 1.28 MHz

The closest used carrier with respect to the regarded carrier of one system is defined by

a minimum difference in centre frequency between the regarded carrier and the carriers used in the other system and the chip rate of the other system.

If the actual allowed interference level $P_{int, allowed, actual}$ at the victim receiver is higher than –106dBm, this requirement may be relaxed by the amount $P_{int, allowed, actual} - (-106dBm)$.

6.6.2.2.3 Requirement in case of co-siting with TDD BS or FDD BS operating on an adjacent frequency

6.6.2.2.3.1 3,84 Mcps TDD option

In case the equipment is co-sited to another TDD BS or FDD BS operating on an adjacent frequency, the ACLR is specified in terms of the absolute transmit power level of the BS measured in the adjacent channel. The maximum power level shall not exceed the limit in table 6.24.

Table 6.24: BS ACLR limits in case of co-siting

BS adjacent channel offset	Maximum Level	Measurement Bandwidth
± 5 MHz	-80 dBm	3.84 MHz
± 10 MHz	-80 dBm	3.84 MHz

The normative reference for this requirement is TS 25.105 [1] subclause 6.6.2.2.3.

NOTE: The necessary dynamic range of the measuring equipment to verify the conformance requirements specified in table 6.24 is dependent on the BS output power. If the BS output power is larger than –10 dBm, the necessary dynamic range is beyond the capability of state-of-the-art measuring equipment; direct verification of the conformance requirements is not feasible. Alternatively, indirect measurement methods need to be defined.

6.6.2.2.3.2 1,28 Mcps TDD option

In case the equipment is co-sited to another TDD BS or FDD BS and both BSs operating on an adjacent frequency band, the requirement is specified in terms of the average power level of the transmitting BS. This requirement is

valid for co-existence with a non-frame and non-switching point synchronised systems operating on closest used carrier. The interference power level shall not exceed the limit in Table 6.24A.

Table 6.24A : BS ACLR in case of co-siting for 1,28 Mcps TDD

Center Frequency for Measurement	Maximum Level of the interference power (in case of multiple antennas the interference powers shall be summed at all antenna connectors)	Measurement Bandwidth
Closest used carrier of the victim receiver: Either FDD carrier Or 3.84 Mcps TDD carrier Or 1.28 Mcps TDD carrier	-76 dBm	chip rate of the victim receiver: In case of FDD: 3.84 MHz In case of 3.84 Mcps TDD: 3.84 MHz In case of 1.28 Mcps TDD: 1.28 MHz

The closest used carrier with respect to the regarded carrier of one system is defined by:

a minimum difference in centre frequency between the regarded carrier and the carriers used in the other system and the chip rate of the other system.

If the actual MCL_{actual} is higher than 30dB, this requirement may be relaxed by the amount MCL_{actual} − 30dB.

If the actual allowed interference level $P_{int, allowed, actual}$ at the victim receiver is higher than –106dBm, this requirement may be relaxed by the amount $P_{int, allowed, actual}$ − (-106dBm).

6.6.2.2.3 Test purpose

The test purpose is to verify the ability of the BS to limit the interference produced by the transmitted signal to other UTRA receivers operating at the first or second adjacent RF channel.

6.6.2.2.4 Method of test

6.6.2.2.4.1 Initial conditions

6.6.2.2.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: B, M and T; see subclause 5.3.

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.25.

Table 6.25: Parameters of the BS transmitted signal for ACLR testing

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	Real life (sufficient irregular)

6.6.2.2.4.1.2 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of the BS under test.

(2) Set the parameters of the BS transmitted signal according to table 6.25A.

Table 6.25A: Parameters of the BS transmitted signal for ACLR testing for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, 3, 4, 5, 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
BS output power setting	PRAT
Number of DPCH in each active TS	8
Power of each DPCH	1/8 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

6.6.2.2.4.2 Procedure

6.6.2.2.4.2.1 3,84 Mcps TDD option

(1) Measure transmitted power over the 2464 active chips of the even time slots TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off α = 0,22 and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points. (The global in-channel Tx test described in Annex C may be applied.)

(2) Average over TBD time slots.

(3) Measure interference power at the first lower adjacent RF channel (center frequency 5 MHz below the assigned channel frequency of the transmitted signal) over the useful part of the burst within the even time slots TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off α = 0,22 and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken with adherence to the sampling theorem.

(4) Average over TBD time slots.

(5) Calculate the ACLR by the ratio

ACLR = transmitted power acc. to (2) / interference power acc. to (4).

(6) Repeat steps (3), (4) and (5) for the second lower adjacent RF channel (center frequency 10 MHz below the assigned channel frequency of the transmitted signal) and also for the first and second upper adjacent RF channel (center frequency 5 MHz and 10 MHz above the assigned channel frequency of the transmitted signal, respectively).

6.6.2.2.4.2.2 1,28 Mcps TDD option

(1) Measure ~~transmittedoutput~~the average power centered on the assigned channel frequency over the 848 active chips of the transmit time slots TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off α = 0,22 and a bandwidth equal to the chip rate. ~~The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken at the decision points. (The global in-channel Tx test described in Annex C may be applied.)~~

(2) Average over TBD time slots.

(3) Measure ~~interference~~the average power at the first lower adjacent RF channel (center frequency 1,6 MHz below the assigned channel frequency of the transmitted signal) over the useful part of the burst within the transmit time slots TS i (this excludes the guard period), and with a measurement filter that has a RRC filter response with a roll off α = 0,22 and a bandwidth equal to the chip rate. The power is determined by calculating the RMS value of the signal samples at the measurement filter output taken with adherence to the sampling theorem.

(4) Average over TBD time slots.

(5) Calculate the ACLR by the ratio:

ACLR = ~~output~~~~transmitted~~average power acc. to (2) / average interference power acc. to (4).

(6) Repeat steps (3), (4) and (5) for the second lower adjacent RF channel (center frequency 3,2 MHz below the assigned channel frequency of the transmitted signal) and also for the first and second upper adjacent RF channel (center frequency 1,6 MHz and 3,2 MHz above the assigned channel frequency of the transmitted signal, respectively).

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Edinburgh, Great Britain, 3rd - 7th September 2001

CR-Form-v4

CHANGE REQUEST

⌘ **25.142** **CR** 86 ⌘ ev **-** ⌘ Current version: **4.1.0** ⌘

*For **HELP** on using this form, see bottom of this page or look at the pop-up text over the ⌘ symbols.*

Proposed change affects: ⌘ (U)SIM ☐ ME/UE ☐ Radio Access Network ☒ Core Network ☐

Title:	⌘	Correction of frequency range for receiver spurious emissions (1,28 Mcps TDD option)
Source:	⌘	RAN WG4
Work item code:	⌘	LCRTDD-RF
Date:	⌘	4 September 2001
Category:	⌘	**F**
Release:	⌘	Rel-4

Use one of the following categories:
F *(correction)*
A *(corresponds to a correction in an earlier release)*
B *(addition of feature),*
C *(functional modification of feature)*
D *(editorial modification)*
Detailed explanations of the above categories can be found in 3GPP TR 21.900.

Use one of the following releases:
2 *(GSM Phase 2)*
R96 *(Release 1996)*
R97 *(Release 1997)*
R98 *(Release 1998)*
R99 *(Release 1999)*
REL-4 *(Release 4)*
REL-5 *(Release 5)*

Reason for change:	⌘	The current frequency range for receiver spurious emission requirements is inconsistent with the value proposed in ITU-R M.[UNWANT-MS].
Summary of change:	⌘	The starting frequency for receiver spurious emission requirements is changed from 9 kHz to 30 MHz as proposed in ITU-R M.[UNWANT-MS].
Consequences if not approved:	⌘	There will be an inconsistency with ITU-R recommendation M.[UNWANT]. It will cause further inconsistencies with future regional or national regulations that will follow the ITU-R recommendation.

Clauses affected:	⌘	
Other specs affected:	⌘	☐ Other core specifications ☐ Test specifications ☐ O&M Specifications
	⌘	
Other comments:	⌘	

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Comprehensive information and tips about how to create CRs can be found at: http://www.3gpp.org/3G_Specs/CRs.htm. Below is a brief summary:

1) Fill out the above form. The symbols above marked ⌘ contain pop-up help information about the field that they are closest to.

2) Obtain the latest version for the release of the specification to which the change is proposed. Use the MS Word "revision marks" feature (also known as "track changes") when making the changes. All 3GPP specifications can be downloaded from the 3GPP server under ftp://ftp.3gpp.org/specs/ For the latest version, look for the directory name with the latest date e.g. 2001-03 contains the specifications resulting from the March 2001 TSG meetings.

3) With "track changes" disabled, paste the entire CR form (use CTRL-A to select it) into the specification just in front of the clause containing the first piece of changed text. Delete those parts of the specification which are not relevant to the change request.

7.7 Spurious emissions

7.7.1 Definition and applicability

The spurious emissions power is the power of emissions generated or amplified in a receiver that appear at the BS antenna connector. The requirements apply to all BS with separate Rx and Tx antenna connectors. For BS equipped with only a single antenna connector for both transmitter and receiver, the requirements of subclause 6.6.3 shall apply to this port, and this test need not be performed.

The requirements in this subclause shall apply to base stations intended for general-purpose applications.

7.7.2 Minimum Requirements

7.7.2.1 3,84 Mcps TDD option

The power of any spurious emission shall not exceed the values given in table 7.12.

Table 7.12: Receiver spurious emission requirements

Band	Maximum level	Measurement Bandwidth	Note
9 kHz – 1 GHz	-57 dBm	100 kHz	
1 GHz – 1,9 GHz	-47 dBm	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
1,900 – 1,980 GHz	-78 dBm	3,84 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
1,980 – 2,010 GHz	-47 dBm	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
2,010 – 2,025 GHz	-78 dBm	3,84 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS
2,025 GHz – 12,75 GHz	-47 dBm	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS

7.7.2.2 1,28 Mcps TDD option

The power of any spurious emission shall not exceed the values given in table 7.12A.

Table 7.12A: Receiver spurious emission requirements for 1,28 Mcps TDD

Band	Maximum level	Measurement Bandwidth	Note
30 MHz~~9 kHz~~ – 1 GHz	-57 dBm	100 kHz	
1 GHz – 1.9 GHz and 1.98 GHz – 2.01 GHz	-47 dBm	1 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.
1.9 GHz – 1.98 GHz and 2.01 GHz – 2.025 GHz	-83 dBm	1.28 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.
2.025 GHz – 12.75 GHz	-47 dBm	1 MHz	With the exception of frequencies between 4MHz below the first carrier frequency and 4MHz above the last carrier frequency used by the BS.

The normative reference for this requirement is TS 25.105 [1] subclause 7.7.1.

7.7.3 Test purpose

The test purpose is to verify the ability of the BS to limit the interference caused by receiver spurious emissions to other systems.

7.7.4 Method of test

7.7.4.1 Initial conditions

7.7.4.1.1 3,84 Mcps TDD option

Test environment: normal; see subclause 5.9.1.

RF channels to be tested: M; see subclause 5.3.

(1) Connect the measuring equipment to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Set the BS receiver to operational mode.

(4) Set the BS to transmit a signal with parameters according to table 7.13.

(5) Terminate the Tx port(s).

Table 7.13: Parameters of the transmitted signal for Rx spurious emissions test

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 14: transmit, if i is even; receive, if i is odd.
BS output power setting	PRAT
Number of DPCH in each active TS	9
Power of each DPCH	1/9 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

7.7.4.1.2 1,28 Mcps TDD option

(1) Connect the measuring equipment to the antenna connector of one BS Rx port.

(2) Terminate or disable any other BS Rx port not under test.

(3) Set the BS receiver to operational mode.

(4) Set the BS to transmit a signal with parameters according to table 7.13A.

(5) Terminate the Tx port(s).

Table 7.13A: Parameters of the transmitted signal for Rx spurious emissions test for 1,28 Mcps TDD

Parameter	Value/description
TDD Duty Cycle	TS i; i = 0, 1, 2, ..., 6: transmit, if i is 0,4,5,6; receive, if i is 1,2,3.
BS output power setting	PRAT
Number of DPCH in each active TS	8
Power of each DPCH	1/8 of Base Station output power
Data content of DPCH	real life (sufficient irregular)

7.7.4.2 Procedure

7.7.4.2.1 3,84 Mcps TDD option

(1) Measure the power of the spurious emissions by applying the measuring equipment with the settings as specified in table 7.14. The characteristics of the measurement filter with the bandwidth 3,84 MHz shall be RRC with roll-off α = 0,22. The characteristics of the measurement filters with bandwidths 100 kHz and 1 MHz shall be approximately Gaussian (typical spectrum analyzer filter). The center frequency of the filters shall be stepped in contiguous steps over the frequency bands as specified in table 7.14. The time duration of each step shall be sufficiently long to capture one even (transmit) time slot.

(2) If the BS is equipped with more than one Rx port, interchange the connections of the BS Rx ports and repeat the measurement according to (1).

Table 7.14: Measurement equipment settings

Stepped frequency range	Measurement bandwidth	Step width	Note	Detection mode
9 kHz – 1 GHz	100 kHz	100 kHz		true RMS
1 GHz – 1,900 GHz	1 MHz	1 MHz	With the exception of frequencies between 12,5 MHz below the first carrier frequency and 12,5 MHz above the last carrier frequency used by the BS	
1,900 GHz – 1,980 GHz	3,84 MHz	200 kHz		
1,980 GHz – 2,010 GHz	1 MHz	1 MHz		
2,010 GHz – 2,025 GHz	3,84 MHz	200 kHz		
2,025 GHz – 12,75 GHz	1 MHz	1 MHz		

7.7.4.2.2 1,28 Mcps TDD option

(1) Measure the power of the spurious emissions by applying the measuring equipment with the settings as specified in table 7.14A. The characteristics of the measurement filter with the bandwidth 1,28 MHz shall be RRC with roll-off α = 0,22. The characteristics of the measurement filters with bandwidths 100 kHz and 1 MHz shall be approximately Gaussian (typical spectrum analyzer filter). The center frequency of the filters shall be stepped in contiguous steps over the frequency bands as specified in table 7.14A. The time duration of each step shall be sufficiently long to capture one even (transmit) time slot.

(2) If the BS is equipped with more than one Rx port, interchange the connections of the BS Rx ports and repeat the measurement according to (1).

Table 7.14A: Measurement equipment settings

Stepped frequency range	Measurement bandwidth	Step width	Note	Detection mode
30 MHz~~9 kHz~~ – 1 GHz	100 kHz	100 kHz		true RMS
1 GHz – 1,900 GHz	1 MHz	1 MHz	With the exception of frequencies between 4 MHz below the first carrier frequency and 4 MHz above the last carrier frequency used by the BS	
1,900 GHz – 1,980 GHz	1,28 MHz	200 kHz		
1,980 GHz – 2,010 GHz	1 MHz	1 MHz		
2,010 GHz – 2,025 GHz	1,28 MHz	200 kHz		
2,025 GHz – 12,75 GHz	1 MHz	1 MHz		

7.7.5 Test Requirements

NOTE: If the Test Requirement below differs from the Minimum Requirement, then the Test Tolerance applied for this test is non-zero. The Test Tolerance for this test is defined in subclause 5.11 and the explanation of how the Minimum Requirement has been relaxed by the Test Tolerance is given in Annex D.

The spurious emissions measured according to subclause 7.7.4.2 shall not exceed the limits specified in subclause 7.7.2.